

# UCC28180、周波数プログラム可能、連続導通モード(CCM)、昇圧力率補正(PFC)コントローラ

## 1 特長

- 8ピンのソリューション(ACライン・センシングが不要)
- スwitchング周波数を広範囲でプログラム可能(MOSFETおよびIGBTベースのPFCコンバータについて18kHz~250kHz)
- 低iTHD向けの調整された電流ループ回路
- 電流感知スレッシュホールドの低下(シャントの消費電力を最小化)
- 平均電流モード制御
- ソフト過電流制限保護とサイクル単位のピーク電流制限保護
- ヒステリシス回復付きの出力過電圧保護
- 可聴ノイズ最小化回路
- 開ループ検出
- 出力過電圧および低電圧状態時の動的応答を強化
- 最大ディーティ・サイクル96% (標準値)
- 無負荷時レギュレーションのためのバースト・モード
- VCC UVLO、低ICCスタートアップ(75μA未満)

## 2 アプリケーション

- ユニバーサルAC入力、CCM昇圧PFCコンバータ(100Wから数kWの範囲)
- サーバおよびデスクトップ用電源
- 白物家電(エアコン、冷蔵庫)
- 産業用電源(DINレール)
- フラット・パネル(PDP、液晶、LED)テレビ

## 3 概要

UCC28180は、柔軟で使いやすい8ピンのアクティブ力率補正(PFC)コントローラです。連続導通モード(CCM)で動作することにより、AC-DCフロントエンドの昇圧プリレギュレータで高い力率、低い電流歪、優れた電圧レギュレーションを実現します。100W~数kWの範囲で動作するユニバーサルAC入力システムに最適であり、switchング周波数を18kHz~250kHzの範囲でプログラミングできるため、パワーMOSFETスイッチとIGBTスイッチの両方をサポートします。内蔵の1.5Aおよび2A(SRC-SNK)ピーク・ゲート駆動出力は、内部で15.2V(標準)にクランプされ、バッファ回路なしで外部のパワー・スイッチを高速でオン/オフし、簡単に管理できます。

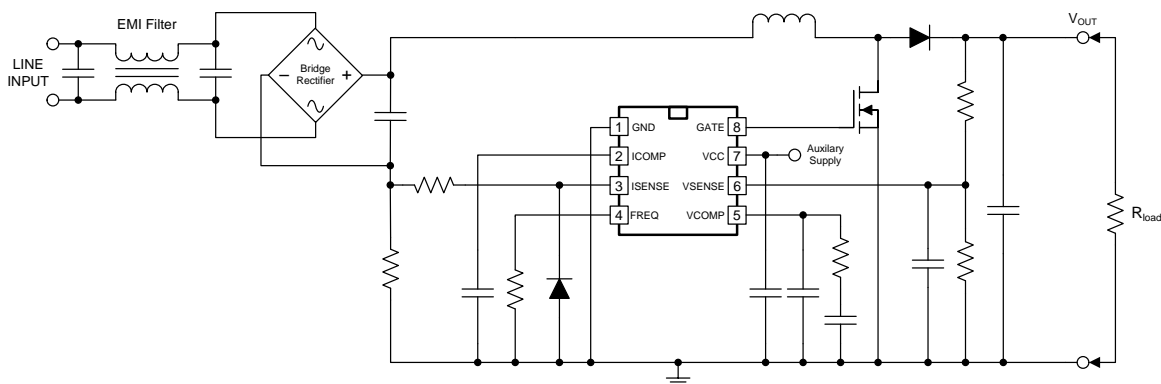
平均電流モード制御による入力電流の低歪波形整形を入力ラインのセンシングなしで実現でき、外部部品数が抑えられます。また、電流センス・スレッシュホールドを低く設定しているため、値の小さなシャント抵抗を使用でき、高電力システムで特に重要となる消費電力の低減に役立ちます。電流の歪を低く抑えるため、調整された内部電流ループ・レギュレーション回路によって、精度の低下を防いでいます。

### 製品情報<sup>(1)</sup>

型番	パッケージ	本体サイズ(公称)
UCC28180	SOIC (8)	4.90mm×3.91mm

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。

代表的なアプリケーションの回路図



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## 4 改訂履歴

### Revision C (April 2016) から Revision D に変更

Page

• 「C 改訂履歴」にある、機能ブロック図へのダイオードの追加のページ番号を正しく変更	2
• 変更 text value of 0.538 to 0.366 to align with 式 85. Updated change was implemented in the C revision and recorded in the D revision.	31
• 追加 D4 to 表 2. Updated change was implemented in the C revision and recorded in the D revision.	37
• 追加 ドキュメントの更新通知を受け取る方法	39
• 追加 コミュニティ・リソース	39

### Revision B (December 2014) から Revision C に変更

Page

• 代表的なアプリケーションの回路図の画像にダイオードを追加	1
• 変更 ICC Standby current MAX rate from 2.95 mA to 3.47 mA.	6
• 変更 ISENSE threshold, soft over current (SOC) TYP value from -0.295 V to -0.285 V.	6
• 変更 Maximum current under EDR operation MAX rating from -241 μA to -275 μA.	6
• 追加 a diode to the Functional Block Diagram.	13
• 追加 Diode to Soft Overcurrent/Peak-Current Limit image.	17
• 追加 ISENSE Pin section.	18
• 追加 diode to the Design Example Schematic image.	22
• 変更 式 101 3kHz to 5kHz.	32
• 変更 Recommended Layout for UCC28180 image.	38

### Revision A (November 2013) から Revision B に変更

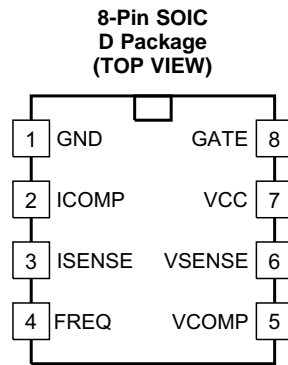
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• 「ESD 定格」表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクション 追加	1
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## 5 概要(続き)

単純な外部ネットワークにより、電流および電圧制御ループを柔軟に補正できます。さらに、UCC28180には拡張された動的応答回路があり、出力過電圧と低電圧の両方の条件において、高速な負荷トランジェント時に、電圧帰還信号に基づいて優れた応答を実現します。UCC28180内の独自のVCOMP放電回路は、電圧帰還信号が $V_{OVP\_L}$ を超えたときにアクティブになり、制御ループを迅速に安定させ、(PWMシャットオフで頻繁に可聴ノイズが発生する場合に)過電圧保護機能の作動を防ぎます。制御されたソフトスタートにより、スタートアップ時には入力電流が漸進的にレギュレートされ、パワー・スイッチへのストレスを低減します。コントローラには、VCC UVLO、ピーク電流制限、ソフト過電流、出力オープン・ループ検出、出力過電圧保護、オープン・ピン検出(VISNS)など、数多くのシステム・レベルの保護機能が用意されています。トリムされた内部リファレンスにより、正確な保護スレッシュホールドとレギュレーション設定ポイントが決定されます。ユーザは、VSENSEピンの電圧を0.82V未満に下げることによって、低電力スタンバイ・モードを制御できます。

## 6 Pin Configuration and Functions



### Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
GATE	8	O	<b>Gate Drive:</b> Integrated push-pull gate driver for one or more external power MOSFETs. Typical 2.0-A sink and 1.5-A source capability. Output voltage is typically clamped at 15.2 V (typical).
GND	1		<b>Ground:</b> device ground reference.
ICOMP	2	O	<b>Current Loop Compensation:</b> Transconductance current amplifier output. A capacitor connected to GND provides compensation and averaging of the current sense signal in the current control loop. The controller is disabled if the voltage on ICOMP is less than 0.2 V, (ICOMPP protection function).
ISENSE	3	I	<b>Inductor Current Sense:</b> Input for the voltage across the external current sense resistor, which represents the instantaneous current through the PFC boost inductor. This voltage is averaged by the current amplifier to eliminate the effects of ripple and noise. <i>Soft Over Current (SOC)</i> limits the average inductor current. <i>Cycle-by-cycle peak current limit (PCL)</i> immediately shuts off the GATE drive if the peak-limit voltage is exceeded. An internal 2.3- $\mu$ A current source pulls ISENSE above 0.085 V to shut down PFC operation if this pin becomes open-circuited, (ISOP protection function). Use a 220- $\Omega$ resistor between this pin and the current sense resistor to limit inrush-surge currents into this pin.
VCC	7		<b>Device Supply:</b> External bias supply input. <i>Under-Voltage Lockout (UVLO)</i> disables the controller until VCC exceeds a turn-on threshold of 11.5 V. Operation continues until VCC falls below the turn-off (UVLO) threshold of 9.5 V. A ceramic by-pass capacitor of 0.1 $\mu$ F minimum value should be connected from VCC to GND as close to the device as possible for high-frequency filtering of the VCC voltage.
VCOMP	5	O	<b>Voltage Loop Compensation:</b> Transconductance voltage error amplifier output. A resistor-capacitor network connected from this pin to GND provides compensation. VCOMP is held at GND until VCC, and VSENSE exceed their threshold voltages. Once these conditions are satisfied, VCOMP is charged until the VSENSE voltage reaches its nominal regulation level. When Enhanced Dynamic Response (EDR) is engaged, a higher transconductance is applied to VCOMP to reduce the charge or discharge time for faster transient response. <i>Soft Start</i> is programmed by the capacitance on this pin. VCOMP is pulled low when VCC UVLO, OLP/Standby, ICOMPP and ISOP functions are activated.
FREQ	4	O	<b>Switching Frequency Setting:</b> This pin allows the setting of the operating switching frequency by connecting a resistor to ground. The programmable frequency range is from 18 kHz to 250 kHz.
VSENSE	6	I	<b>Output Voltage Sense:</b> An external resistor-divider network connected from this pin to the PFC output voltage provides feedback sensing for regulation to the internal 5-V reference voltage. A small capacitor from this pin to GND filters high-frequency noise. Standby disables the controller and discharges VCOMP when the voltage at VSENSE drops below the Open-Loop Protection (OLP) threshold of 16.5% $V_{REF}$ (0.82 V). An internal 100-nA current source pulls VSENSE to GND during pin disconnection. <i>Enhanced Dynamic Response (EDR)</i> rapidly returns the output voltage to its normal regulation level when a system line or load step causes VSENSE to rise above 105% or fall below 95% of the reference voltage. Two level <i>Output Over-Voltage Protection (OVP)</i> : a 4-k $\Omega$ resistor connects VCOMP to ground to rapidly discharge VCOMP when VSENSE exceeds 107% ( $V_{OVP\_L}$ ) of the reference voltage. If VSENSE exceeds 109% ( $V_{OVP\_H}$ ) of the reference voltage, GATE output will be disabled until VSENSE drops below 102% of the reference voltage.

## 7 Specifications

### 7.1 Absolute Maximum Ratings<sup>(1)</sup>

Over operating free-air temperature range, all voltages are with respect to GND (unless otherwise noted). Currents are positive into and negative out of the specified terminal.

		MIN	MAX	UNIT
Input voltage range	VCC, GATE	-0.3	22	V
	FREQ, VSENSE, VCOMP, ICOMP	-0.3	7	
Input current range	ISENSE	-24	7	
	VSENSE, ISENSE	-1	1	mA
Junction temperature, T <sub>J</sub>	Operating	-55	150	°C
Lead temperature, T <sub>SOL</sub>	Soldering, 10 s		300	°C
Storage temperature, T <sub>stg</sub>		-65	150	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those included under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods of time may affect device reliability.

### 7.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.  
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
VCC input voltage from a low-impedance source	VCC <sub>OFF</sub> + 1V	21	V
Operating junction temperature, T <sub>J</sub>	-40	125	°C
Operating frequency	18	250	kHz

### 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		UCC28180	UNIT
		D	
		8 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance <sup>(2)</sup>	116.1	°C/W
R <sub>θJctop</sub>	Junction-to-case (top) thermal resistance <sup>(3)</sup>	62.2	
R <sub>θJB</sub>	Junction-to-board thermal resistance <sup>(4)</sup>	56.4	
ψ <sub>JT</sub>	Junction-to-top characterization parameter <sup>(5)</sup>	14.4	
ψ <sub>JB</sub>	Junction-to-board characterization parameter <sup>(6)</sup>	55.9	

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report (SPRA953).  
 (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.  
 (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.  
 (4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.  
 (5) The junction-to-top characterization parameter, ψ<sub>JT</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining R<sub>θJA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).  
 (6) The junction-to-board characterization parameter, ψ<sub>JB</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining R<sub>θJA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).

## 7.5 Electrical Characteristics

Unless otherwise noted, VCC=15Vdc, 0.1µF from VCC to GND, -40°C ≤ T<sub>J</sub> = T<sub>A</sub> ≤ +125°C. All voltages are with respect to GND. Currents are positive into and negative out of the specified terminal.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>VCC BIAS SUPPLY</b>						
ICC <sub>PRESTART</sub>	ICC Pre-start current	VCC = VCC <sub>OFF</sub> - 0.2 V			75	µA
ICC <sub>STBY</sub>	ICC Standby current	VSENSE = 0.5 V	1.8	2.4	3.47	mA
ICC <sub>ON_load</sub>	ICC Operating current	VSENSE = 4.0 V, C <sub>GATE</sub> = 4.7 nF	5.8	7	8.8	mA
<b>UNDER VOLTAGE LOCKOUT (UVLO)</b>						
VCC <sub>ON</sub>	VCC Turn on threshold		10.8	11.5	12.1	V
VCC <sub>OFF</sub>	VCC Turn off threshold		9.1	9.5	10.3	V
	UVLO Hysteresis		1.6	1.7	2	V
<b>VARIABLE FREQUENCY</b>						
f <sub>SW</sub>	Minimum switching frequency	R <sub>FREQ</sub> = 130 kΩ	16.3	18	19.8	kHz
	Typical switching frequency	R <sub>FREQ</sub> = 32.7 kΩ	61.75	65	68.25	kHz
	Maximum switching frequency	R <sub>FREQ</sub> = 8.2 kΩ	225	250	275	kHz
V <sub>FREQ</sub>	Voltage at FREQ pin	T <sub>A</sub> = 25°C	1.43	1.5	1.56	V
<b>PWM</b>						
D <sub>MIN</sub>	Minimum duty cycle	VSENSE = 5.1 V, ISENSE = -0.25 V			0%	
D <sub>MAX</sub>	Maximum duty cycle	VSENSE = 4.0 V, R <sub>FREQ</sub> = 32.7 Ω	94.8%	96.5%	98%	
t <sub>OFF(min)</sub>	Minimum off time	VSENSE = 3 V, I <sub>COMP</sub> = 0.72 V	450	570	690	ns
<b>SYSTEM PROTECTION</b>						
V <sub>SOC</sub>	ISENSE threshold, soft over current (SOC)		-0.259	-0.285	-0.312	V
V <sub>PCL</sub>	ISENSE threshold, peak current limit (PCL)		-0.345	-0.4	-0.438	V
I <sub>ISOP</sub>	ISENSE bias current, ISENSE open-pin protection (ISOP)	ISENSE = 0 V		-2.3	-2.95	µA
V <sub>ISOP</sub>	ISENSE threshold, ISENSE open-pin protection (ISOP)	ISENSE = open pin		0.085	0.14	V
V <sub>OLP</sub>	VSENSE threshold, open loop protection (OLP)	ICOMP = 1 V, ISENSE = 0 V	15.6	16.5	17.6	%V <sub>REF</sub>
	Open loop protection (OLP) Internal pull-down current	VSENSE = 0.5 V		100	325	nA
V <sub>UVD</sub>	VSENSE threshold, output under-voltage detection (UVD) used for enhanced dynamic response <sup>(1)</sup>		93.25	95	97	%V <sub>REF</sub>
V <sub>OVD</sub>	VSENSE threshold, output over-voltage detection (OVD) used for Enhanced dynamic response <sup>(1)</sup>		103	105	106.75	%V <sub>REF</sub>
V <sub>OVP_L</sub>	Output over-voltage protection low threshold, VCOMP is discharged by a 4kΩ resistor when VSENSE > V <sub>OVP_L</sub>		105	107	109	%V <sub>REF</sub>
V <sub>OVP_H</sub>	Output over-voltage protection high threshold, PWM shuts off when VSENSE > V <sub>OVP_H</sub>		107	109	111	%V <sub>REF</sub>
V <sub>OVP_H(RST)</sub>	Output over-voltage protection (VOVP_H) reset threshold, PWM turns on when VSENSE < V <sub>OVP_H(RST)</sub>		100	102	104	%V <sub>REF</sub>
	ICOMP threshold, external overload protection			0.2	0.25	%V <sub>REF</sub>
<b>CURRENT LOOP</b>						
g <sub>mi</sub>	Transconductance gain		0.75	0.95	1.1	mS
	Output linear range <sup>(1)</sup>			±50		µA
	ICOMP voltage during OLP	VSENSE = 0 V	2.7	3	3.3	V
<b>VOLTAGE LOOP</b>						
V <sub>REF</sub>	Reference voltage	T <sub>A</sub> = 25°C	4.93	5	5.07	V
		-40°C ≤ T <sub>A</sub> ≤ +125°C	4.87	5	5.15	V
g <sub>mv</sub>	Transconductance gain without EDR		-40	-56	-70	µS
g <sub>mv-EDR</sub>	Transconductance gain under EDR		-230	-280	-340	µS
	Maximum sink current under normal operation	VSENSE = 5 V, VCOMP = 4 V	23	40	57	µA
	Source current under soft start	VSENSE = 4 V, VCOMP = 4 V	-29	-40	-52	µA
	Maximum current under EDR operation	VSENSE = 4 V, VCOMP = 2.5 V	-200	-275		µA

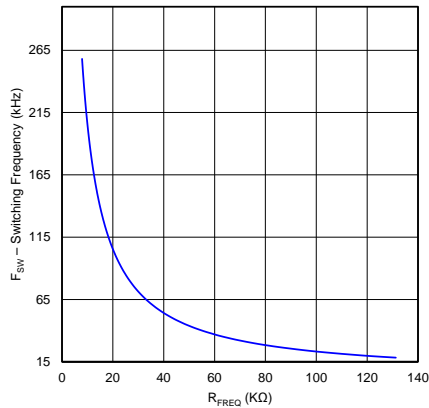
(1) Not production tested. Characterized by design

## Electrical Characteristics (continued)

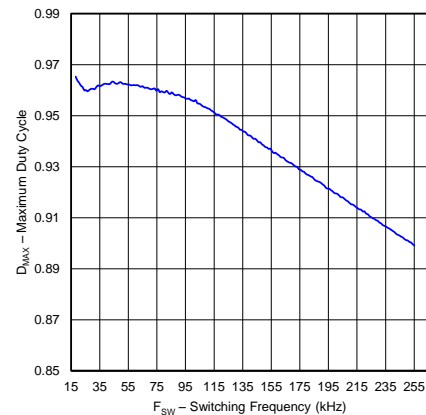
Unless otherwise noted, VCC=15Vdc, 0.1μF from VCC to GND,  $-40^{\circ}\text{C} \leq T_J = T_A \leq +125^{\circ}\text{C}$ . All voltages are with respect to GND. Currents are positive into and negative out of the specified terminal.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VSENSE input bias current	VSENSE = 5 V	20	100	250	nA
VCOMP voltage during OLP	VSENSE = 0.5 V, I <sub>VCOMP</sub> = 0.5 mA	0	0.04	0.10	V
VCOMP rapid discharge current	VCOMP = 2 V, VCC = floating		0.37		mA
V <sub>PRECHARGE</sub> VCOMP precharge voltage	I <sub>VCOMP</sub> = -100 μA, VSENSE = 4 V		1.5		V
I <sub>PRECHARGE</sub> VCOMP precharge current	VCOMP = 0 V		-1		mA
VSENSE threshold, end-of-soft-start	Initial Start-up		98		%V <sub>REF</sub>
<b>GATE DRIVER</b>					
GATE current, peak, sinking <sup>(1)</sup>	C <sub>GATE</sub> = 4.7 nF		2		A
GATE current, peak, sourcing <sup>(1)</sup>	C <sub>GATE</sub> = 4.7 nF		-1.5		A
GATE rise time	C <sub>GATE</sub> = 4.7 nF, GATE = 2 V to 8 V	8	40	60	ns
GATE fall time	C <sub>GATE</sub> = 4.7 nF, GATE = 8 V to 2 V	8	25	40	ns
GATE low voltage, no load	I <sub>GATE</sub> = 0 A		0	0.01	V
GATE low voltage, sinking	I <sub>GATE</sub> = 20 mA		0.04	0.06	V
GATE low voltage, sourcing	I <sub>GATE</sub> = -20 mA		-0.04	-0.06	V
GATE low voltage, sinking, OFF	VCC = 5 V, I <sub>GATE</sub> = 5 mA	0.1	0.2	0.31	V
GATE low voltage, sinking, OFF	VCC = 5 V, I <sub>GATE</sub> = 20 mA	0.4	0.8	1.4	V
GATE high voltage	VCC = 20 V, C <sub>GATE</sub> = 4.7 nF	14.5	15.2	16.1	V
GATE high voltage	VCC = 12.2 V, C <sub>GATE</sub> = 4.7 nF	10.8	11.2	12	V
GATE high voltage	VCC = VCC <sub>OFF</sub> + 0.2 V, C <sub>GATE</sub> = 4.7 nF	8.2	9	10.1	V

## 7.6 Typical Characteristics

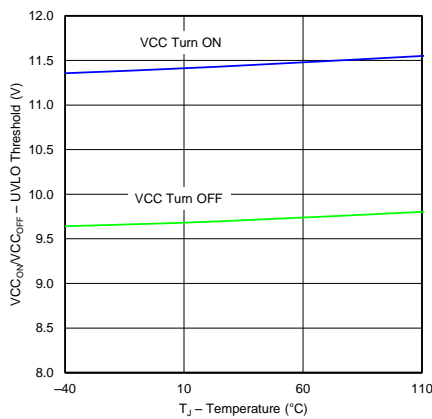


1. Switching Frequency vs. Resistor

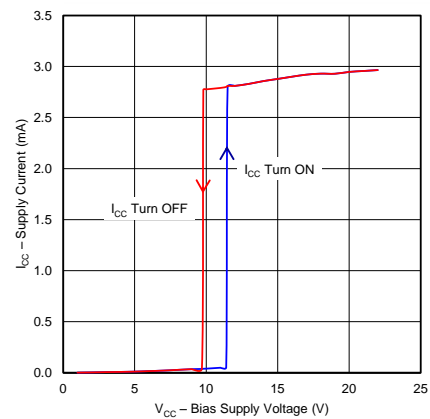


VCC = 15 V

2. Maximum Duty Cycle vs. Switching Frequency

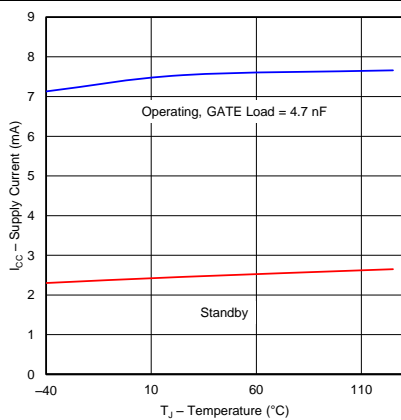


3. UVLO Threshold vs. Temperature



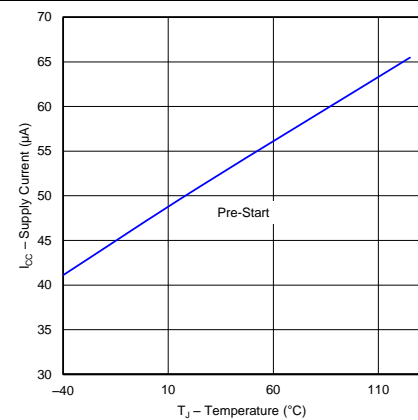
T<sub>J</sub> = 25 °C  
No Gate Load  
V<sub>SENSE</sub> = 3 V  
F<sub>SW</sub> = 65 kHz

4. Supply Current vs. Bias Supply Voltage



VCC = 15 V

5. Supply Current vs. Temperature

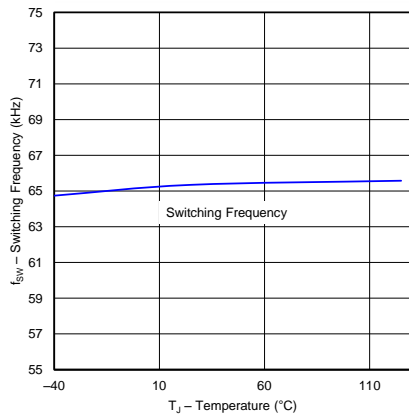


VCC = VCC<sub>ON</sub> - 0.2 V

6. Pre-Start Supply Current vs. Temperature

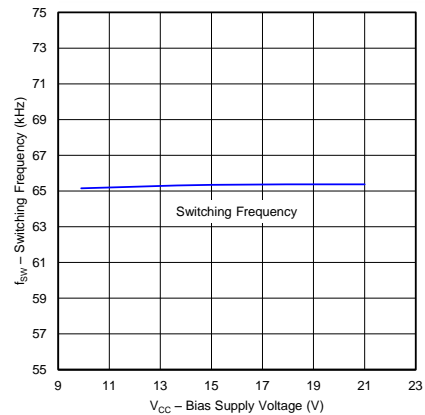


Typical Characteristics (continued)



VCC = 15 V F<sub>SW</sub> = 65 kHz

Fig 7. Oscillator Frequency (65 kHz) vs. Temperature



T<sub>J</sub> = 25 °C F<sub>SW</sub> = 65 kHz

Fig 8. Oscillator Frequency (65 kHz) vs. Bias Supply Voltage

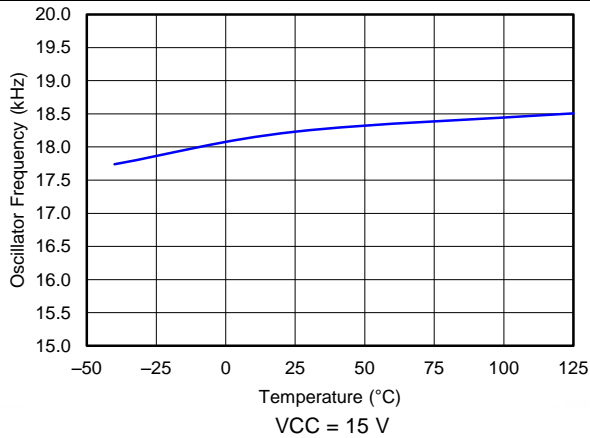


Fig 9. Oscillator Frequency (18 kHz) vs. Temperature

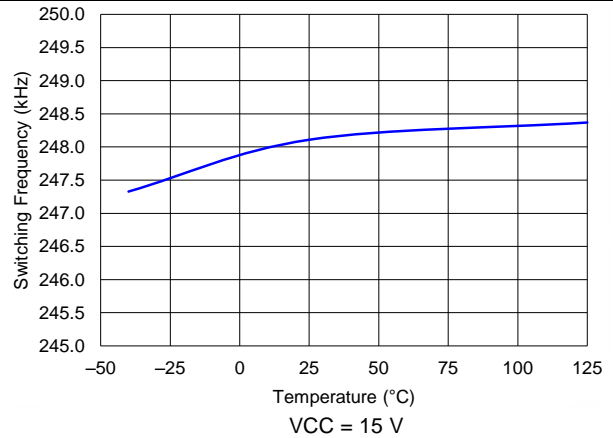


Fig 10. Oscillator Frequency (250 kHz) vs. Temperature

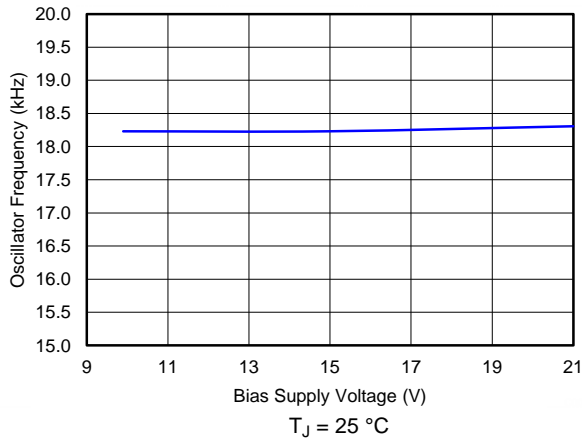


Fig 11. Oscillator Frequency (18 kHz) vs. Bias Voltage

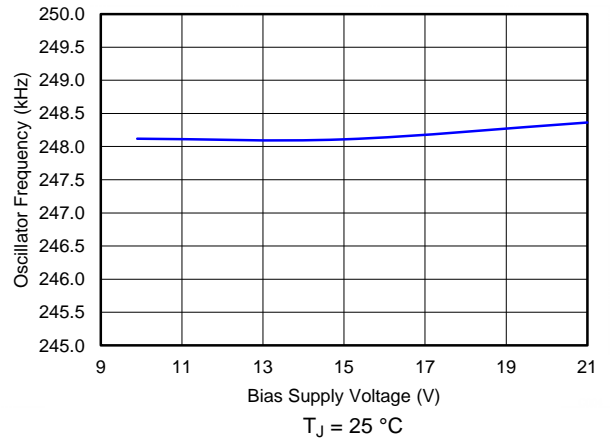
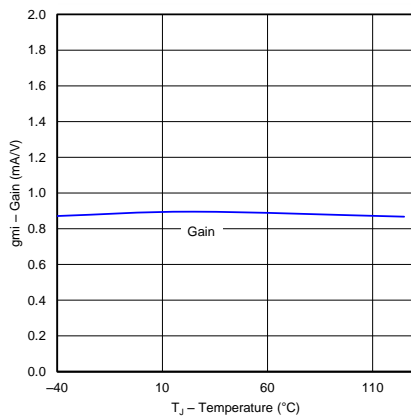


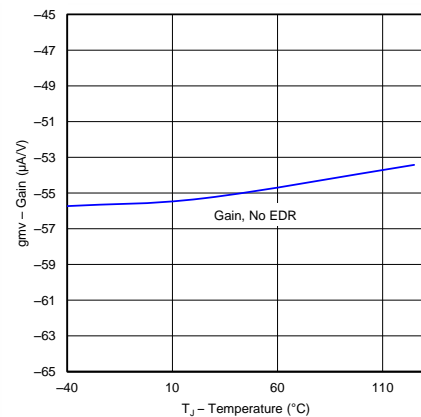
Fig 12. Oscillator Frequency (250 kHz) vs. Bias Voltage

Typical Characteristics (continued)



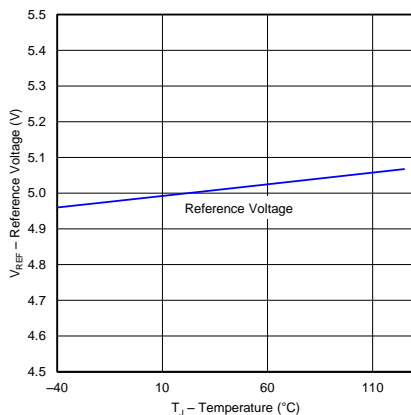
VCC = 15 V

13. Current Loop Gain vs. Temperature



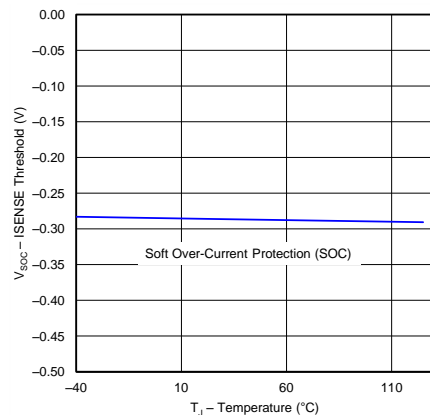
VCC = 15 V

14. Voltage Loop Gain vs. Temperature



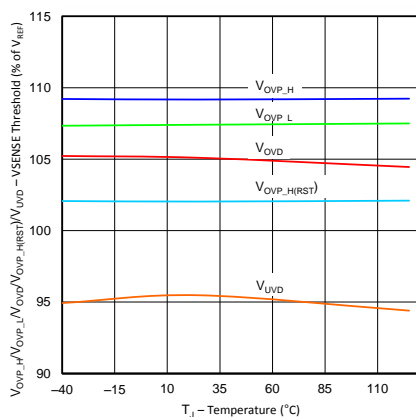
VCC = 15 V

15. Reference Voltage vs. Temperature



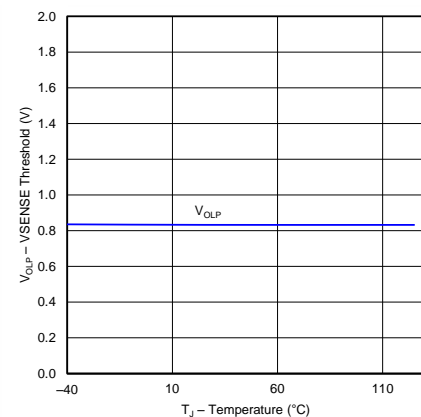
VCC = 15 V

16. ISENSE Threshold Soft Over Current (SOC) vs. Temperature



VCC = 15 V

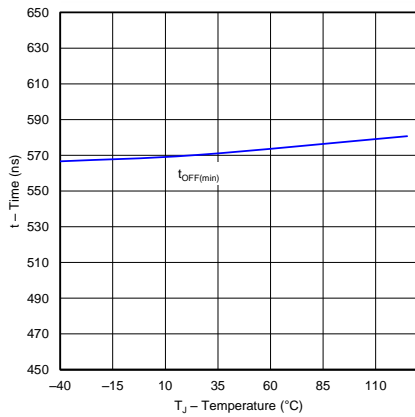
17. VSENSE Threshold vs. Temperature



VCC = 15 V

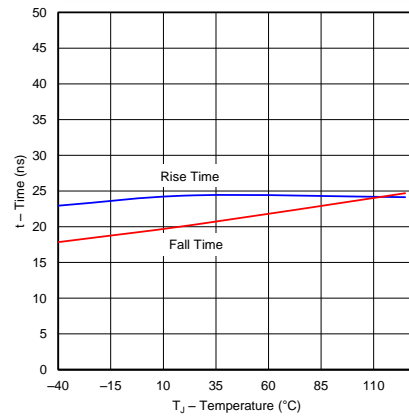
18. VSENSE Threshold Open Loop vs. Temperature

**Typical Characteristics (continued)**



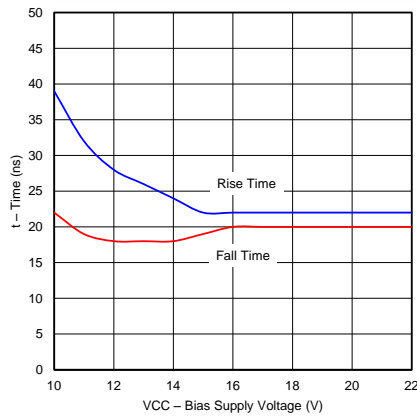
ICOMP = 0.72 V      VSENSE = 3 V      F<sub>SW</sub> = 65 kHz

**图 19. Minimum Off Time vs. Temperature**



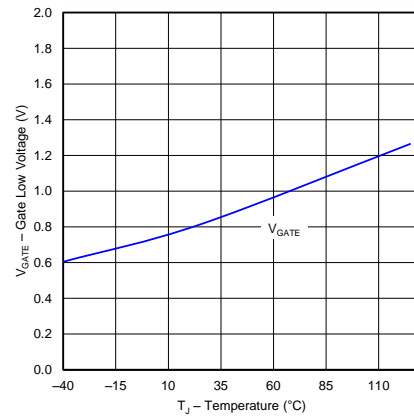
VCC = 15 V      C<sub>GATE</sub> = 4.7 nF      V<sub>GATE</sub> = 2 V-8 V

**图 20. Gate Drive Rise/Fall Time vs. Temperature**



T<sub>J</sub> = 25 °C      C<sub>GATE</sub> = 4.7 nF      V<sub>GATE</sub> = 2 V-8 V

**图 21. Gate Drive Rise/Fall Time vs. Bias Supply Voltage**



VCC = 15 V      I<sub>GATE</sub> = 20 mA

**图 22. Gate Low Voltage vs. Temperature**

## 8 Detailed Description

### 8.1 Overview

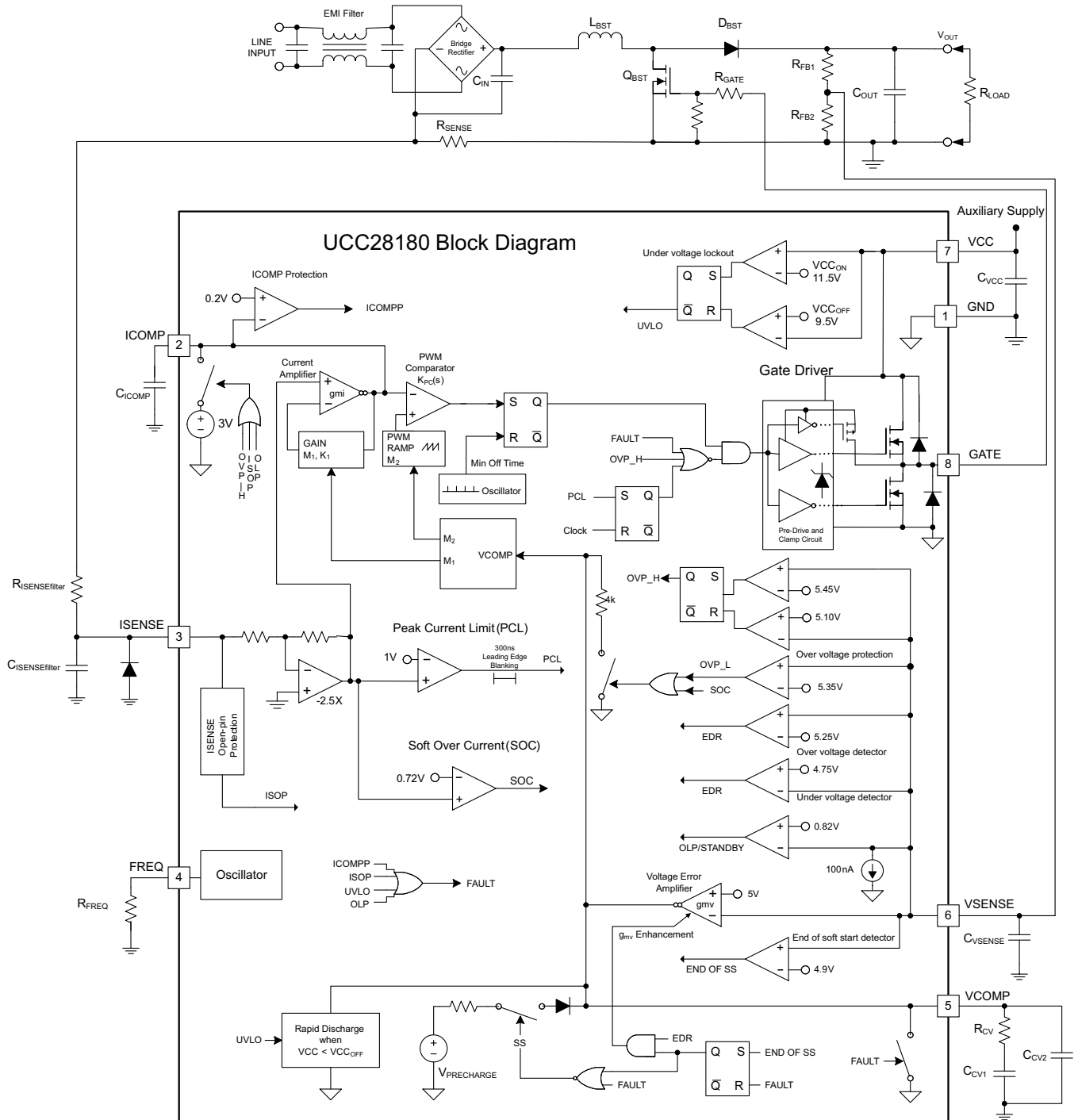
The UCC28180 is a boost controller for power factor correction operating at a fixed frequency in continuous conduction mode. The UCC28180 requires few external components to operate as an active PFC pre-regulator.

UCC28180 employs two control loops. An internal error amplifier and 5-V reference provide a slow outer loop to control output voltage. External compensation of this outer loop is applied by means of the VCOMP pin. The inner current loop shapes the average input current to match the sinusoidal input voltage. The inner current loop avoids the need to sense input voltage by exploiting the relationship between input voltage and boost duty-cycle. External compensation of the inner current loop is applied by means of the ICOMP pin.

The operating switching frequency can be programmed from 18 kHz to 250 kHz simply by connecting the FREQ pin to ground through a resistor.

UCC28180 includes a number of protection functions designed to ensure it is reliable, and will provide safe operation under all conditions, including abnormal or fault conditions.

## 8.2 Functional Block Diagram



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### 8.3 Feature Description

#### 8.3.1 Soft Start

Soft-Start controls the rate of rise of VCOMP in order to obtain a linear control of the increasing duty cycle as a function of time. VCOMP, the output of the voltage loop transconductance amplifier, is pulled low during UVLO, ICOMP, ISOP and OLP (Open-Loop Protection)/STANDBY. Once the fault condition is released, an initial pre-charge source rapidly charges VCOMP to 1.5 V. After that point, a constant 40  $\mu$ A of current is sourced into the compensation components causing the voltage on this pin to ramp linearly until the output voltage reaches 85% of its final value. At this point, the sourcing current decreases until the output voltage reaches its final rated voltage. The soft-start time is controlled by the voltage error amplifier compensation capacitor values selected, and is user programmable based on desired loop crossover frequency. Once the output voltage exceeds 98% of rated voltage, soft start is over, the initial pre-charge source is disconnected, and EDR is no longer inhibited.

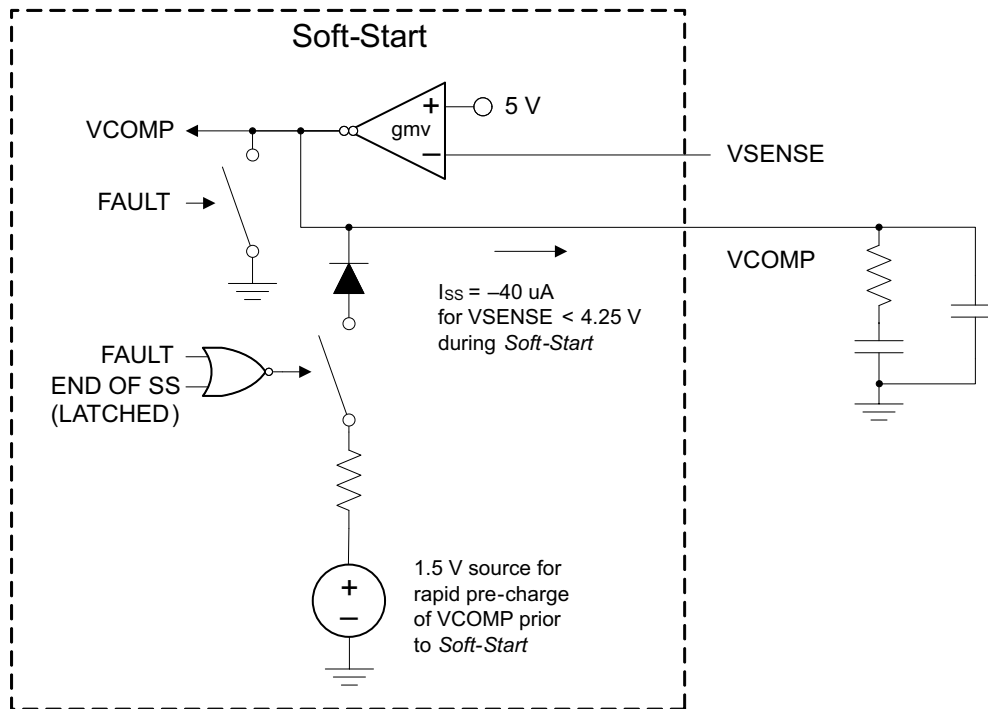


图 23. Soft Start

#### 8.3.2 System Protection

System-level protection features help keep the system within safe operating limits.

#### 8.3.3 VCC Undervoltage LockOut (UVLO)

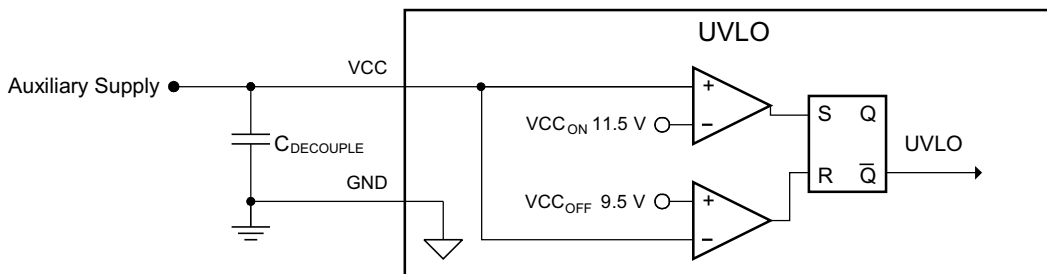


图 24. UVLO

## Feature Description (continued)

During startup, Under-Voltage LockOut (UVLO) keeps the device in the off state until VCC rises above the 11.5-V enable threshold,  $V_{CC_{ON}}$ . With a typical 1.7 V of hysteresis on UVLO to increase noise immunity, the device turns off when VCC drops to the 9.5-V disable threshold,  $V_{CC_{OFF}}$ .

If, during a brief AC-line dropout, the VCC voltage falls below the level necessary to bias the internal FAULT circuitry, the UVLO condition enables a special rapid discharge circuit which continues to discharge the VCOMP capacitors through a low impedance despite a complete lack of VCC. This helps to avoid an excessive current surge should the AC-line return while there is still substantial voltage stored on the VCOMP capacitors. Typically, these capacitors can be discharged to less than 1 V within 150 ms of loss of VCC.

### 8.3.4 Output Overvoltage Protection (OVP)

There are two levels of OVP: When VSENSE exceeds 107% ( $V_{OVP\_L}$ ) of the reference voltage, a 4-k $\Omega$  resistor connects VCOMP to ground to rapidly discharge VCOMP. If VSENSE exceeds 109% ( $V_{OVP\_H}$ ) of the reference voltage, GATE output is disabled until VSENSE drops below 102% of the reference voltage.

### 8.3.5 Open Loop Protection/Standby (OLP/Standby)

If the output voltage feedback components were to fail and disconnect (open loop) the signal from the VSENSE input, then it is likely that the voltage error amp would increase the GATE output to maximum duty cycle. To prevent this, an internal pull-down forces VSENSE low. If the output voltage falls below 16.5% of its rated voltage, causing VSENSE to fall below 0.82 V, the device is put in standby, a state where the PWM switching is halted and the device is still on but draws standby current below 2.95 mA. This shutdown feature also gives the designer the option of pulling VSENSE low with an external switch (standby function).

### 8.3.6 ISENSE Open-Pin Protection (ISOP)

If the current feedback components were to fail and disconnect (open loop) the signal to the ISENSE input, then it is likely that the PWM stage would increase the GATE output to maximum duty cycle. To prevent this, an internal pull-up source drives ISENSE above 0.085 V so that a detector forces a state where the PWM switching is halted and the device is still on but draws standby current below 2.95 mA. This shutdown feature avoids continual operation in OVP and severely distorted input current.

### 8.3.7 ICOMP Open-Pin Protection (ICOMPP)

If the ICOMP pin shorts to ground, then the GATE output increases to maximum duty cycle. To prevent this, once ICOMP pin voltage falls below 0.2 V, the PWM switching is halted and the device is still on but draws standby current below 2.95 mA.

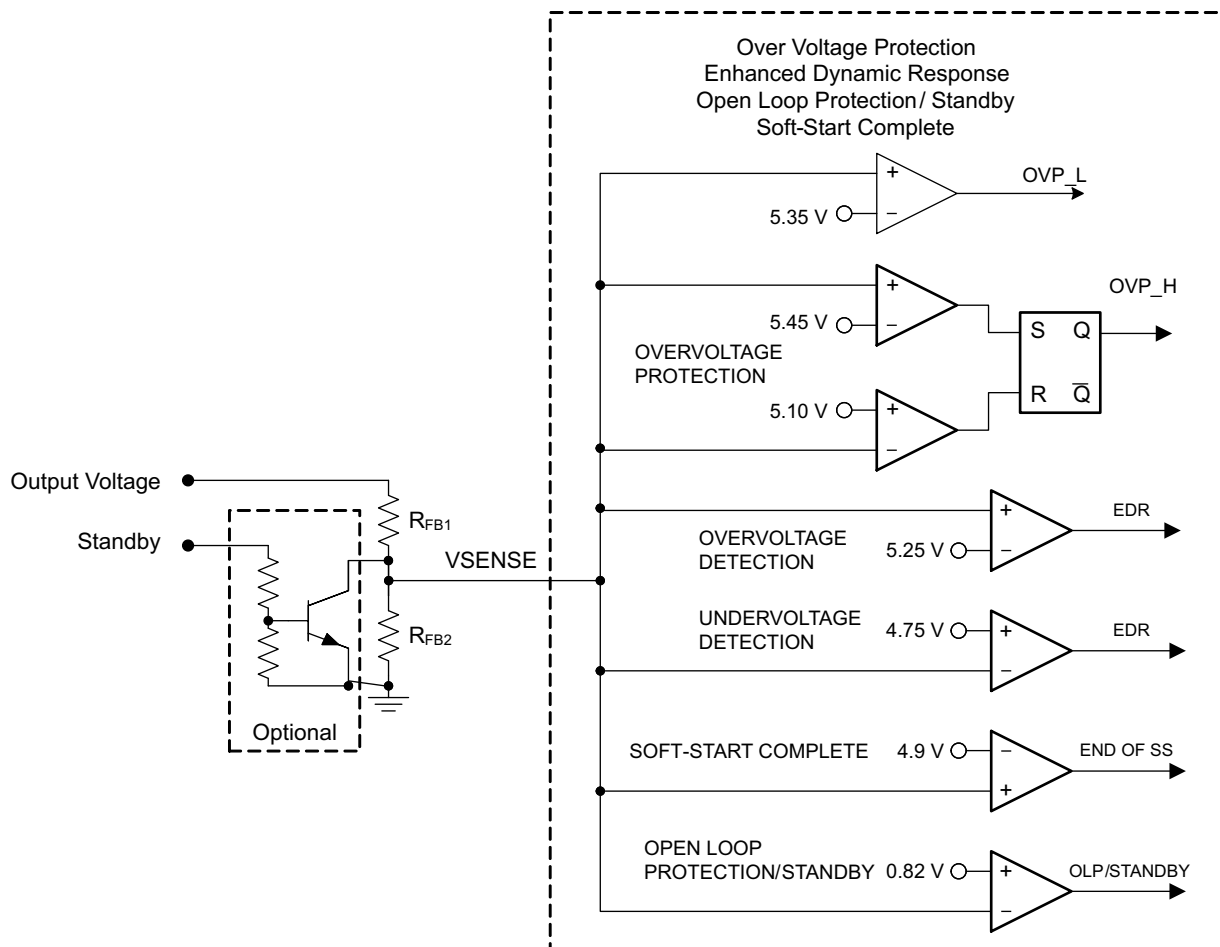
### 8.3.8 FAULT Protection

VCC UVLO, OLP/Standby, ISOP and ICOMPP functions constitute the fault protection feature in the UCC28180. Under fault protection, VCOMP pin is pulled low and the device is in standby.

### 8.3.9 Output Overvoltage Detection (OVD), Undervoltage Detection (UVD) and Enhanced Dynamic Response (EDR)

During normal operation, small perturbations on the PFC output voltage rarely exceed  $\pm 5\%$  deviation and the normal voltage control loop gain drives the output back into regulation. For large changes in line or load, if the output voltage perturbation exceeds  $\pm 5\%$ , an output over-voltage (OVD) or under-voltage (UVD) is detected and Enhanced Dynamic Response (EDR) acts to speed up the slow response of the low-bandwidth voltage loop. During EDR, the transconductance of the voltage error amplifier is increased approximately five times to speed charging or discharging the voltage-loop compensation capacitors to the level required for regulation. EDR is disabled when  $5.25\text{ V} > V_{SENSE} > 4.75\text{ V}$ . The EDR feature is not activated until soft start is completed. The UVD is disabled during soft over protection (SOC) condition (since UVD and SOC conflict with each other).

Feature Description (continued)



25. OVP\_H, OVP\_L, EDR, OLP, Soft Start Complete

8.3.10 Overcurrent Protection

Inductor current is sensed by  $R_{ISENSE}$ , a low value resistor in the return path of input rectifier. The other side of the resistor is tied to the system ground. The voltage is sensed on the rectifier side of the sense resistor and is always negative. The voltage at ISENSE is buffered by a fixed gain of -2.5 to provide a positive internal signal to the current functions. There are two overcurrent protection features; Soft Overcurrent (SOC) protects against an overload on the output and Peak Current Limit (PCL) protects against inductor saturation.



Feature Description (continued)

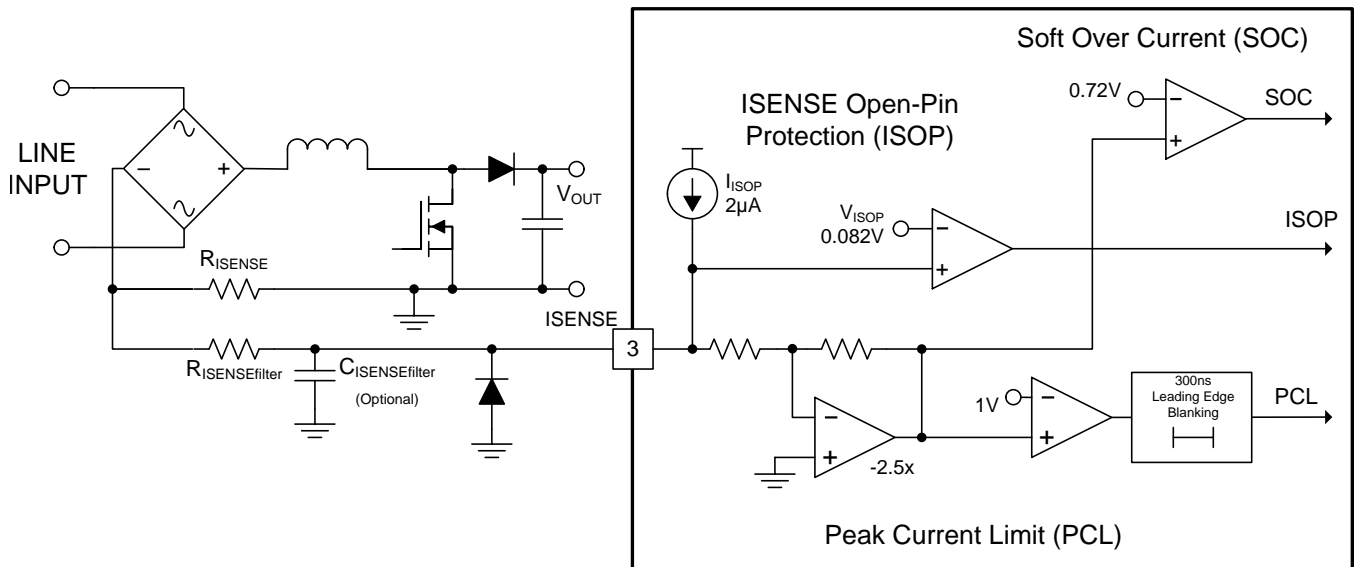


Figure 26. Soft Overcurrent/Peak-Current Limit

8.3.11 Soft Overcurrent (SOC)

Soft Overcurrent (SOC) limits the input current. SOC is activated when the current sense voltage on ISENSE reaches  $-0.285\text{ V}$ . This is a soft control as it does not directly switch off the gate driver. Instead a  $4\text{-k}\Omega$  resistor connects VCOMP to ground to discharge VCOMP and the control loop is adjusted to reduce the PWM duty cycle. The under-voltage detection (UVD) is disabled during SOC.

8.3.12 Peak Current Limit (PCL)

Peak Current Limit (PCL) operates on a cycle-by-cycle basis. When the current sense voltage on ISENSE reaches  $-0.4\text{ V}$ , PCL is activated, immediately terminating the active switch cycle. PCL is leading-edge blanked to improve noise immunity against false triggering.

8.3.13 Current Sense Resistor,  $R_{ISENSE}$

The current sense resistor,  $R_{ISENSE}$ , is sized using the minimum threshold value of Soft Over Current (SOC),  $V_{SOC(min)}$ . To avoid triggering this threshold during normal operation, resulting in a decreased duty-cycle, the resistor is sized for an overload current of 10% more than the peak inductor current,

$$R_{ISENSE} \leq \frac{V_{SOC(min)}}{1.1 I_{L\_PEAK(max)}} \tag{1}$$

Since  $R_{ISENSE}$  “sees” the average input current, worst-case power dissipation occurs at input low-line when input current is at its maximum. Power dissipated by the sense resistor is given by:

$$P_{RISENSE} = (I_{IN\_RMS(max)})^2 R_{ISENSE} \tag{2}$$

Peak current limit (PCL) protection turns off the output driver when the voltage across the sense resistor reaches the PCL threshold,  $V_{PCL}$ . The absolute maximum peak current,  $I_{PCL}$ , is given by:

$$I_{PCL} = \frac{V_{PCL} / 2.5}{R_{ISENSE}} \tag{3}$$

## Feature Description (continued)

### 8.3.14 ISENSE Pin

The voltage at the ISENSE pin should be limited between 0 V and  $-1.1$  V. Inrush currents at start-up have the potential to drive the ISENSE pin significantly more negative so a diode clamp should be used between ISENSE and GND to prevent the ISENSE pin going more negative than  $1.1$  V, (see [Figure 26](#)). The diode  $V_f$  should be greater than the maximum PCL threshold ( $-0.438$  V) and less than  $-1.1$  V across temperature and component variations.

### 8.3.15 Gate Driver

The GATE output is designed with a current-optimized structure to directly drive large values of total MOSFET/IGBT gate capacitance at high turn-on and turn-off speeds. An internal clamp limits voltage on the MOSFET gate to  $15.2$  V (typical). When VCC voltage is below the UVLO level, the GATE output is held in the off state. An external gate drive resistor,  $R_{GATE}$ , can be used to limit the rise and fall times and dampen ringing caused by parasitic inductances and capacitances of the gate drive circuit and to reduce EMI. The final value of the resistor depends upon the parasitic elements associated with the layout and other considerations. A  $10\text{-k}\Omega$  resistor close to the gate of the MOSFET/IGBT, between the gate and ground, discharges stray gate capacitance and helps protect against inadvertent  $dv/dt$ -triggered turn-on.

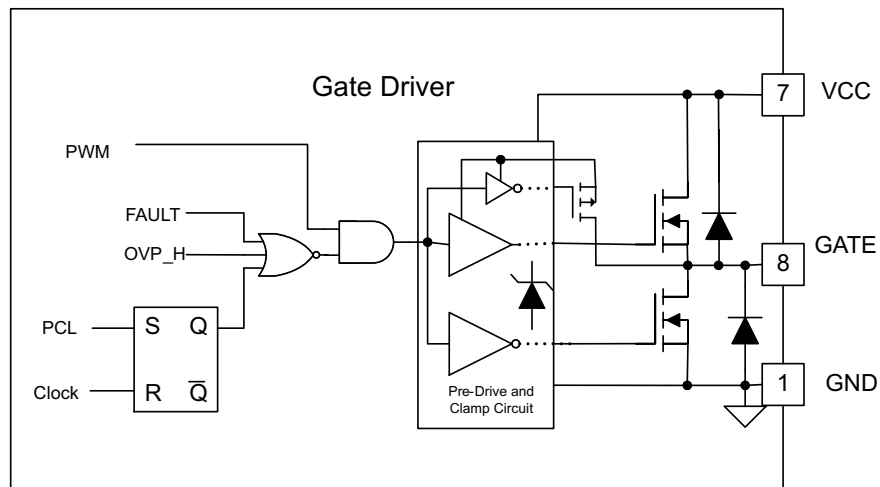


Figure 27. Gate Driver

### 8.3.16 Current Loop

The overall system current loop consists of the current averaging amplifier stage, the pulse width modulator (PWM) stage, the external boost inductor stage and the external current sensing resistor.

### 8.3.17 ISENSE and ICOMP Functions

The negative polarity signal from the current sense resistor is buffered and inverted at the ISENSE input. The internal positive signal is then averaged by the current amplifier ( $g_{mi}$ ), whose output is the ICOMP pin. The voltage on ICOMP is proportional to the average inductor current. An external capacitor to GND is applied to the ICOMP pin for current loop compensation and current ripple filtering. The gain of the averaging amplifier is determined by the internal VCOMP voltage. This gain is non-linear to accommodate the world-wide AC-line voltage range.

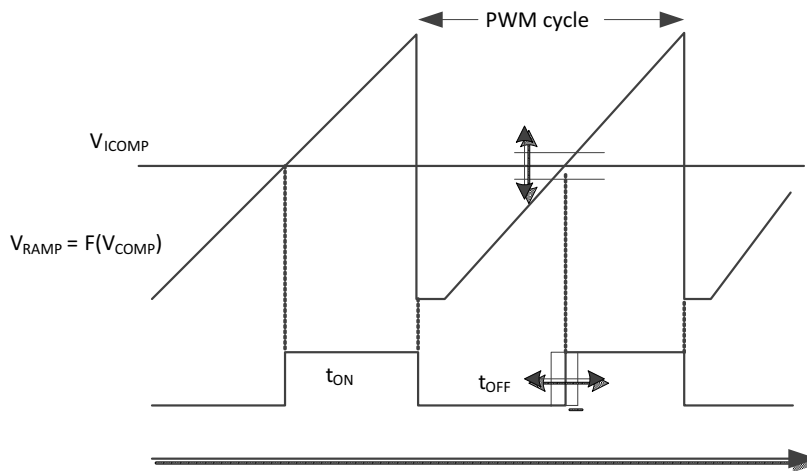
ICOMP is connected to 3-V internally whenever OVP\_H, ISOP, or OLP is triggered.

### 8.3.18 Pulse Width Modulator

The PWM stage compares the ICOMP signal with a periodic ramp to generate a leading-edge-modulated output signal which is high whenever the ramp voltage exceeds the ICOMP voltage. The slope of the ramp is defined by a non-linear function of the internal VCOMP voltage.

**Feature Description (continued)**

The PWM output signal always starts low at the beginning of the cycle, triggered by the internal clock. The output stays low for a minimum off-time,  $t_{OFF\_min}$ , after which the ramp rises linearly to intersect the ICOMP voltage. The ramp-ICOMP intersection determines  $t_{OFF}$ , and hence  $D_{OFF}$ . Since  $D_{OFF} = V_{IN}/V_{OUT}$  by the boost-topology equation, and since  $V_{IN}$  is sinusoidal in wave-shape, and since ICOMP is proportional to the inductor current, it follows that the control loop forces the inductor current to follow the input voltage wave-shape to maintain boost regulation. Therefore, the average input current is also sinusoidal in wave-shape.



**28. PWM Generation**

**8.3.19 Control Logic**

The output of the PWM comparator stage is conveyed to the GATE drive stage, subject to control by various protection functions incorporated into the device. The GATE output duty-cycle may be as high as 98%, but always has a minimum off-time  $t_{OFF\_min}$ . Normal duty-cycle operation can be interrupted directly by OVP\_H and PCL. UVLO, ISOP, ICOMM and OLP/Standby also terminate the GATE output pulse, and further inhibit output until the SS operation can begin.

**8.3.20 Voltage Loop**

The outer control loop of the PFC controller is the voltage loop. This loop consists of the PFC output sensing stage, the voltage error amplifier stage, and the non-linear gain generation.

**8.3.21 Output Sensing**

A resistor-divider network from the PFC output voltage to GND forms the sensing block for the voltage control loop. The resistor ratio is determined by the desired output voltage and the internal 5-V regulation reference voltage.

The very low bias current at the VSENSE input allows the choice of the highest practicable resistor values for lowest power dissipation and standby current. A small capacitor from VSENSE to GND serves to filter the signal in a high-noise environment. This filter time constant should generally be less than 100  $\mu$ s.

**8.3.22 Voltage Error Amplifier**

The transconductance error amplifier ( $g_{mv}$ ) generates an output current proportional to the difference between the voltage feedback signal at VSENSE and the internal 5-V reference. This output current charges or discharges the compensation network capacitors on the VCOMP pin to establish the proper VCOMP voltage for the system operating conditions. Proper selection of the compensation network components leads to a stable PFC pre-regulator over the entire AC-line range and 0% to 100% load range. The total capacitance also determines the rate-of-rise of the VCOMP voltage at *Soft Start*, as discussed earlier.

## Feature Description (continued)

The amplifier output VCOMP is pulled to GND during any fault or standby condition to discharge the compensation capacitors to an initial zero state. Usually, the large capacitor has a series resistor which delays complete discharge for their respective time constant (which may be several hundred milliseconds). If VCC bias voltage is quickly removed after UVLO, the normal discharge transistor on VCOMP loses drive and the large capacitor could be left with substantial voltage on it, negating the benefit of a subsequent *Soft Start*. The UCC28180 incorporates a parallel discharge path which operates without VCC bias, to further discharge the compensation network after VCC is removed.

If the output voltage perturbations exceed  $\pm 5\%$ , and output over-voltage (OVD) or under-voltage (UVD) is detected, the OVD or UVD function invokes EDR which immediately increases the voltage error amplifier transconductance to about  $280 \mu\text{S}$ . This higher gain facilitates faster charging or discharging the compensation capacitors to the new operating level. When output voltage perturbations greater than  $107\%V_{\text{REF}}$  appear at the VSENSE input, a  $4\text{-k}\Omega$  resistor connects VCOMP to ground to quickly reduce VCOMP voltage. When output voltage perturbations are greater than  $109\%V_{\text{REF}}$ , the GATE output is shut off until VSENSE drops below 102% of regulation.

### 8.3.23 Non-Linear Gain Generation

The voltage at VCOMP is used to set the current amplifier gain and the PWM ramp slope. This voltage is subject to modification by the SOC function, as discussed earlier.

Together the current gain and the PWM slope adjust to the different system operating conditions (set by the AC-line voltage and output load level) as VCOMP changes, to provide a low-distortion, high-power-factor, input-current wave shape following that of the input voltage.

## 8.4 Device Functional Modes

This device has no functional modes.

## 9 Application and Implementation

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### 注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

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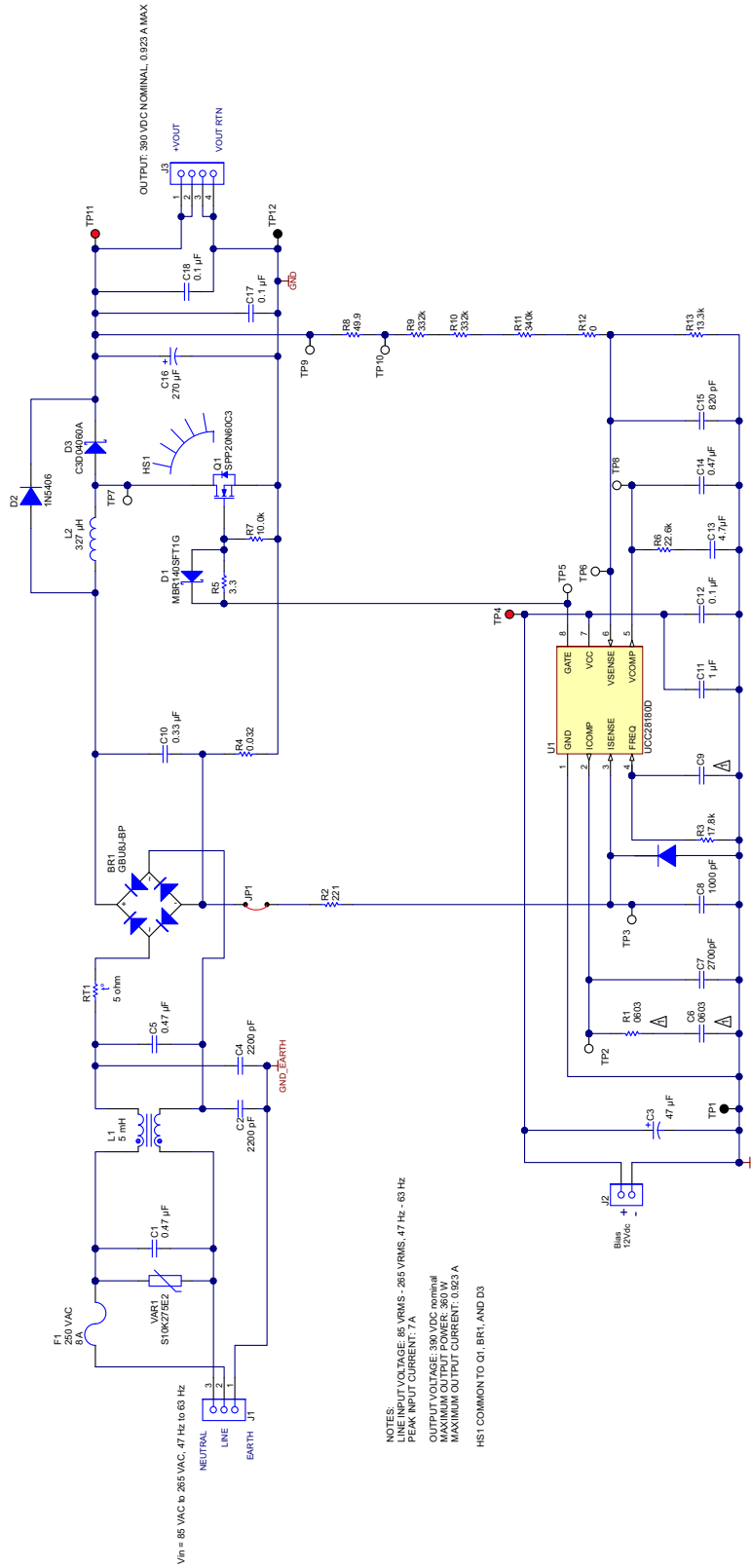
### 9.1 Application Information

The UCC28180 is a switch-mode controller used in boost converters for power factor correction operating at a fixed frequency in continuous conduction mode. The UCC28180 requires few external components to operate as an active PFC pre-regulator. The operating switching frequency can be programmed from 18 kHz to 250 kHz simply by connecting the FREQ pin to ground through a resistor.

The internal 5-V reference voltage provides for accurate output voltage regulation over the typical world-wide 85-VAC to 265-VAC mains input range from zero to full output load. The usable system load ranges from 100 W to few kW.

Regulation is accomplished in two loops. The inner current loop shapes the average input current to match the sinusoidal input voltage under continuous inductor current conditions. Under light-load conditions, depending on the boost inductor value, the inductor current may go discontinuous but still meet Class-A/D requirements of IEC 61000-3-2 despite the higher harmonics. The outer voltage loop regulates the PFC output voltage by generating a voltage on VCOMP (dependent upon the line and load conditions) which determines the internal gain parameters for maintaining a low-distortion, steady-state, input-current wave shape.

9.2 Typical Application



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⚠ Do Not Populate

⚠ WARNING! HIGH VOLTAGE COMPONENTS MAY GET HOT

29. Design Example Schematic

## Typical Application (continued)

### 9.2.1 Design Requirements

This example illustrates the design process and component selection for a continuous mode power factor correction boost converter utilizing the UCC28180. The pertinent design equations are shown for a universal input, 360-W PFC converter with an output voltage of 390 V.

**表 1. Design Goal Parameters**

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>INPUT CHARACTERISTICS</b>						
$V_{IN}$	Input voltage		85		265	$V_{AC}$
$f_{LINE}$	Input frequency		47		63	Hz
$I_{IN(peak)}$	Peak input current	$V_{IN} = V_{IN(min)}$ , $I_{OUT} = I_{OUT(max)}$		7		A
<b>OUTPUT CHARACTERISTICS</b>						
$V_{OUT}$	Output voltage	$V_{IN(min)} \leq V_{IN} \leq V_{IN(max)}$ , $f_{LINE(min)} \leq f_{LINE} \leq f_{LINE(max)}$ , $I_{OUT} \leq I_{OUT(max)}$	379	390	402	VDC
	Line Regulation	$V_{IN(min)} \leq V_{IN} \leq V_{IN(max)}$ , $I_{OUT} = I_{OUT(max)}$			5%	
	Load Regulation	$V_{IN} = 115 V_{AC}$ , $f_{LINE} = 60 Hz$ , $I_{OUT(min)} \leq I_{OUT} \leq I_{OUT(max)}$			5%	
		$V_{IN} = 230 V_{AC}$ , $f_{LINE} = 60 Hz$ , $I_{OUT(min)} \leq I_{OUT} \leq I_{OUT(max)}$			5%	
$I_{OUT}$	Output Load Current	$V_{IN(min)} \leq V_{IN} \leq V_{IN(max)}$ , $f_{LINE(min)} \leq f_{LINE} \leq f_{LINE(max)}$	0		0.923	A
$P_{OUT}$	Output Power	$V_{IN(min)} \leq V_{IN} \leq V_{IN(max)}$ , $f_{LINE(min)} \leq f_{LINE} \leq f_{LINE(max)}$	0		360	W
$V_{RIPPLE(SW)}$	High frequency Output voltage ripple	$V_{IN} = 115 V_{AC}$ , $f_{LINE} = 60 Hz$ , $I_{OUT} = I_{OUT(max)}$		2.5	3.9	$V_{P-P}$
		$V_{IN} = 230 V_{AC}$ , $f_{LINE} = 50 Hz$ , $I_{OUT} = I_{OUT(max)}$		2.5	3.9	
$V_{RIPPLE(f_{LINE})}$	Line frequency Output voltage ripple	$V_{IN} = 115 V_{AC}$ , $f_{LINE} = 60 Hz$ , $I_{OUT} = I_{OUT(max)}$		11.6	19.5	$V_{P-P}$
		$V_{IN} = 230 V_{AC}$ , $f_{LINE} = 50 Hz$ , $I_{OUT} = I_{OUT(max)}$		13.3	19.5	
$V_{OUT(OVP)}$	Output overvoltage protection			425		V
$V_{OUT(UVP)}$	Output undervoltage protection			370		

**Typical Application (continued)**
**表 1. Design Goal Parameters (continued)**

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>CONTROL LOOP CHARACTERISTICS</b>						
$f_{SW}$	Switching frequency	$T_J = 25^\circ\text{C}$	114	120	126	kHz
$f_{(CO)}$	Voltage Loop Bandwidth	$V_{IN} = 162\text{ VDC},$ $I_{OUT} = 0.466\text{ A}$		8		Hz
	Voltage Loop Phase Margin	$V_{IN} = 162\text{ VDC},$ $I_{OUT} = 0.466\text{ A}$		68		°
PF	Power Factor	$V_{IN} = 115\text{ VAC},$ $I_{OUT} = I_{OUT(max)}$		0.99		
THD	Total harmonic distortion	$V_{IN} = 115\text{ VAC},$ $f_{LINE} = 60\text{ Hz},$ $I_{OUT} = I_{OUT(max)}$		4.3%	10%	
		$V_{IN} = 230\text{ VAC},$ $f_{LINE} = 50\text{ Hz},$ $I_{OUT} = I_{OUT(max)}$		4%	10%	
$\eta$	Full load efficiency	$V_{IN} = 115\text{ VAC},$ $f_{LINE} = 60\text{ Hz},$ $I_{OUT} = I_{OUT(max)}$		94%		
	Ambient temperature			25		°C

**9.2.2 Detailed Design Procedure**
**9.2.2.1 Current Calculations**

The input fuse, bridge rectifier, and input capacitor are selected based upon the input current calculations. First, determine the maximum average output current,  $I_{OUT(max)}$ :

$$I_{OUT(max)} = \frac{P_{OUT(max)}}{V_{OUT}} \quad (4)$$

$$I_{OUT(max)} = \frac{360\text{ W}}{390\text{ V}} \cong 0.923\text{ A} \quad (5)$$

The maximum input RMS line current,  $I_{IN\_RMS(max)}$ , is calculated using the parameters from [表 1](#) and the efficiency and power factor initial assumptions:

$$I_{IN\_RMS(max)} = \frac{P_{OUT(max)}}{\eta V_{IN(min)} PF} \quad (6)$$

$$I_{IN\_RMS(max)} = \frac{360\text{ W}}{0.94 \times 85\text{ V} \times 0.99} = 4.551\text{ A} \quad (7)$$

Based upon the calculated RMS value, the maximum input current,  $I_{IN(max)}$ , and the maximum average input current,  $I_{IN\_AVG(max)}$ , assuming the waveform is sinusoidal, can be determined.

$$I_{IN(max)} = \sqrt{2} I_{IN\_RMS(max)} \quad (8)$$

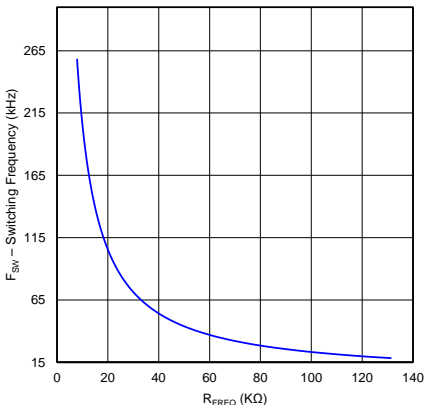
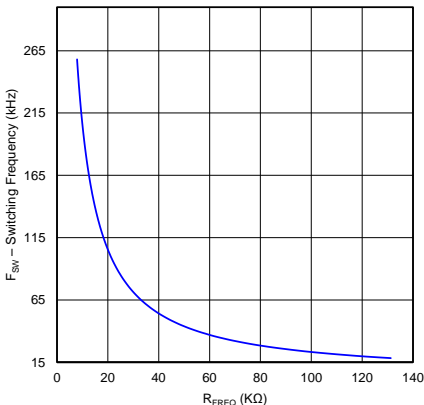
$$I_{IN(max)} = \sqrt{2} \times 4.551\text{ A} = 6.436\text{ A} \quad (9)$$

$$I_{IN\_AVG(max)} = \frac{2 I_{IN(max)}}{\pi} \quad (10)$$

$$I_{IN\_AVG(max)} = \frac{2 \times 6.436\text{ A}}{\pi} = 4.097\text{ A} \quad (11)$$



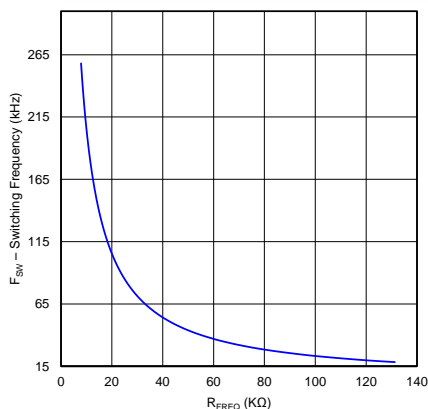
**9.2.2.2 Switching Frequency**

The UCC28180 switching frequency is user programmable with a single resistor on the FREQ pin to ground. For this design, the switching frequency,  $f_{SW}$ , was chosen to be 120 kHz.  (same as ) could be used to select the suitable resistor to program the switching frequency or the value can be calculated using constant scaling values of  $f_{TYP}$  and  $R_{TYP}$ . In all cases,  $f_{TYP}$  is a constant that is equal to 65 kHz,  $R_{INT}$  is a constant that is equal to 1 MΩ, and  $R_{TYP}$  is a constant that is equal to 32.7 kΩ. Simply applying the calculation below yields the appropriate resistor that should be placed between FREQ and GND:

$$R_{FREQ} = \frac{f_{TYP} \times R_{TYP} \times R_{INT}}{(f_{SW} \times R_{INT}) + (R_{TYP} \times f_{SW}) - (R_{TYP} \times f_{TYP})} \tag{12}$$

$$R_{FREQ} = \frac{65\text{kHz} \times 32.7\text{k}\Omega \times 1\text{M}\Omega}{(120\text{kHz} \times 1\text{M}\Omega) + (32.7\text{k}\Omega \times 120\text{kHz}) - (32.7\text{k}\Omega \times 65\text{kHz})} = 17.451\text{k}\Omega \tag{13}$$

A typical value of 17.8 kΩ for the FREQ resistor results in a switching frequency of 118 kHz.



**Figure 30. Frequency vs.  $R_{FREQ}$**

**9.2.2.3 Bridge Rectifier**

The input bridge rectifier must have an average current capability that exceeds the input average current. Assuming a forward voltage drop,  $V_{F\_BRIDGE}$ , of 1 V across the rectifier diodes, BR1, the power loss in the input bridge,  $P_{BRIDGE}$ , can be calculated:

$$P_{BRIDGE} = 2V_{F\_BRIDGE}I_{IN\_AVG(max)} \tag{14}$$

$$P_{BRIDGE} = 2 \times 1\text{V} \times 4.097\text{A} = 8.195\text{W} \tag{15}$$

Heat sinking will be required to maintain operation within the bridge rectifier’s safe operating area.

**9.2.2.4 Inductor Ripple Current**

The UCC28180 is a Continuous Conduction Mode (CCM) controller but if the chosen inductor allows relatively high-ripple current, the converter will be forced to operate in Discontinuous Mode (DCM) at light loads and at the higher input voltage range. High-inductor ripple current has an impact on the CCM/DCM boundary and results in higher light-load THD, and also affects the choices for the input capacitor,  $R_{SENSE}$  and  $C_{ICOMP}$  values. Allowing an inductor ripple current,  $\Delta I_{RIPPLE}$ , of 20% or less will result in CCM operation over the majority of the operating range but requires a boost inductor that has a higher inductance value and the inductor itself will be physically large. As with all converter designs, decisions must be made at the onset in order to optimize performance with size and cost. In this design example, the inductor is sized in such a way as to allow a greater amount of ripple current in order to minimize space with the understanding that the converter operates in DCM at the higher input voltages and at light loads but optimized for a nominal input voltage of 115  $V_{AC}$  at full load. Although specifically defined as a CCM controller, the UCC28180 is shown in this application to meet the overall performance goals while transitioning into DCM at high-line voltage, at a higher load level.

### 9.2.2.5 Input Capacitor

The input capacitor must be selected based upon the input ripple current and an acceptable high frequency input voltage ripple. Allowing an inductor ripple current,  $\Delta I_{\text{RIPPLE}}$ , of 40% and a high frequency voltage ripple factor,  $\Delta V_{\text{RIPPLE\_IN}}$ , of 7%, the maximum input capacitor value,  $C_{\text{IN}}$ , is calculated by first determining the input ripple current,  $I_{\text{RIPPLE}}$ , and the input voltage ripple,  $V_{\text{IN\_RIPPLE}}$ :

$$I_{\text{RIPPLE}} = \Delta I_{\text{RIPPLE}} I_{\text{IN(max)}} \quad (16)$$

$$\Delta I_{\text{RIPPLE}} = 0.4 \quad (17)$$

$$I_{\text{RIPPLE}} = 0.4 \times 6.436 \text{ A} = 2.575 \text{ A} \quad (18)$$

$$V_{\text{IN\_RIPPLE}} = \Delta V_{\text{RIPPLE\_IN}} V_{\text{IN\_RECTIFIED(min)}} \quad (19)$$

$$\Delta V_{\text{RIPPLE\_IN}} = 0.07 \quad (20)$$

$$V_{\text{IN\_RECTIFIED}} = \sqrt{2} V_{\text{IN}} \quad (21)$$

$$V_{\text{IN\_RECTIFIED}} = \sqrt{2} \times 85 \text{ V} = 120 \text{ V} \quad (22)$$

$$V_{\text{IN\_RIPPLE}} = 0.07 \times 120 \text{ V} = 8.415 \text{ V} \quad (23)$$

The recommended value for the input x-capacitor can now be calculated:

$$C_{\text{IN}} = \frac{I_{\text{RIPPLE}}}{8 f_{\text{SW}} V_{\text{IN\_RIPPLE}}} \quad (24)$$

$$C_{\text{IN}} = \frac{2.575 \text{ A}}{8 \times 118 \text{ kHz} \times 8.415 \text{ V}} = 0.324 \mu\text{F} \quad (25)$$

A standard value 0.33- $\mu\text{F}$  Y2/X2 film capacitor is used.

### 9.2.2.6 Boost Inductor

Based upon the allowable inductor ripple current discussed above, the boost inductor,  $L_{\text{BST}}$ , is selected after determining the maximum inductor peak current,  $I_{\text{L\_PEAK}}$ :

$$I_{\text{L\_PEAK(max)}} = I_{\text{IN(max)}} + \frac{I_{\text{RIPPLE}}}{2} \quad (26)$$

$$I_{\text{L\_PEAK(max)}} = 6.436 \text{ A} + \frac{2.575 \text{ A}}{2} = 7.724 \text{ A} \quad (27)$$

The minimum value of the boost inductor is calculated based upon the acceptable ripple current,  $I_{\text{RIPPLE}}$ , at a worst case duty cycle of 0.5:

$$L_{\text{BST(min)}} \geq \frac{V_{\text{OUT}} D(1-D)}{f_{\text{SW}} I_{\text{RIPPLE}}} \quad (28)$$

$$L_{\text{BST(min)}} \geq \frac{390 \text{ V} \times 0.5(1-0.5)}{118 \text{ kHz} \times 2.575 \text{ A}} \geq 321 \mu\text{H} \quad (29)$$

The recommended minimum value for the boost inductor assuming a 40% ripple current is 321  $\mu\text{H}$ ; the actual value of the boost inductor that will be used is 327  $\mu\text{H}$ . With this actual value used, the actual resultant inductor current ripple will be:

$$L_{\text{BST}} = 327 \mu\text{H} \quad (30)$$

$$I_{\text{RIPPLE(actual)}} = \frac{V_{\text{OUT}} D(1-D)}{f_{\text{SW}} L_{\text{BST}}} \quad (31)$$

$$I_{\text{RIPPLE(actual)}} = \frac{390 \text{ V} \times 0.5(1-0.5)}{118 \text{ kHz} \times 327 \mu\text{H}} = 2.527 \text{ A} \quad (32)$$

$$I_{\text{L\_PEAK(max)}} = 6.436 \text{ A} + \frac{2.527 \text{ A}}{2} = 7.7 \text{ A} \quad (33)$$

The duty cycle is a function of the rectified input voltage and will be continuously changing over the half line cycle. The duty cycle,  $DUTY_{(max)}$ , can be calculated at the peak of the minimum input voltage:

$$DUTY_{(max)} = \frac{V_{OUT} - V_{IN\_RECTIFIED(min)}}{V_{OUT}} \quad (34)$$

$$V_{IN\_RECTIFIED(min)} = \sqrt{2} \times 85 \text{ V} = 120 \text{ V} \quad (35)$$

$$DUTY_{(max)} = \frac{390 \text{ V} - 120 \text{ V}}{390 \text{ V}} = 0.692 \quad (36)$$

### 9.2.2.7 Boost Diode

The diode losses are estimated based upon the forward voltage drop,  $V_F$ , at 125°C and the reverse recovery charge,  $Q_{RR}$ , of the diode. Using a silicon carbide Schottky diode, although more expensive, will essentially eliminate the reverse recovery losses and result in less power dissipation:

$$P_{DIODE} = V_{F\_125C} I_{OUT(max)} + 0.5 f_{SW} V_{OUT} Q_{RR} \quad (37)$$

$$V_{F\_125C} = 1 \text{ V} \quad (38)$$

$$Q_{RR} = 0 \text{ nC} \quad (39)$$

$$P_{DIODE} = (1 \text{ V} \times 0.923 \text{ A}) + (0.5 \times 119 \text{ kHz} \times 390 \text{ V} \times 0 \text{ nC}) = 0.923 \text{ W} \quad (40)$$

This output diode should have a blocking voltage that exceeds the output over voltage of the converter and be attached to an appropriately sized heat sink.

### 9.2.2.8 Switching Element

The MOSFET/IGBT switch will be driven by a GATE output that is clamped at 15.2 V for VCC bias voltages greater than 15.2 V. An external gate drive resistor is recommended to limit the rise time and to dampen any ringing caused by the parasitic inductances and capacitances of the gate drive circuit; this will also help in meeting any EMI requirements of the converter. The design example uses a 3.3-Ω resistor; the final value of any design is dependent upon the parasitic elements associated with the layout of the design. To facilitate a fast turn off, a standard 40-V, 1-A Schottky diode is placed anti-parallel with the gate drive resistor. A 10-kΩ resistor is placed between the gate of the MOSFET/IGBT and ground to discharge the gate capacitance and protect from inadvertent dv/dt triggered turn-on.

The conduction losses of the switch MOSFET, in this design are estimated using the  $R_{DS(on)}$  at 125°C, found in the device data sheet, and the calculated drain to source RMS current,  $I_{DS\_RMS}$ :

$$P_{COND} = I_{DS\_RMS}^2 R_{DS(on)125C} \quad (41)$$

$$R_{DS(on)125C} = 0.35 \Omega \quad (42)$$

$$I_{DS\_RMS} = \frac{P_{OUT(max)}}{V_{IN\_RECTIFIED(min)}} \sqrt{2 - \frac{16 V_{IN\_RECTIFIED(min)}}{3\pi V_{OUT}}} \quad (43)$$

$$I_{DS\_RMS} = \frac{360 \text{ W}}{120 \text{ V}} \sqrt{2 - \frac{16 \times 120 \text{ V}}{3\pi \times 390 \text{ V}}} = 3.639 \text{ A} \quad (44)$$

$$P_{COND} = 3.639 \text{ A}^2 \times 0.35 \Omega = 4.636 \text{ W} \quad (45)$$

The switching losses are estimated using the rise time,  $t_r$ , and fall time,  $t_f$ , of the MOSFET gate, and the output capacitance losses.

$$t_r = 5 \text{ ns}$$

$$t_f = 4.5 \text{ ns}$$

$$C_{OSS} = 780 \text{ pF} \quad (46)$$

$$P_{SW} = f_{SW} \left[ 0.5 V_{OUT} I_{IN(max)} (t_r + t_f) + 0.5 C_{OSS} V_{OUT}^2 \right] \quad (47)$$

$$P_{SW} = 118 \text{ kHz} \left[ 0.5 \times 390 \text{ V} \times 6.436 \text{ A} (5 \text{ ns} + 4.5 \text{ ns}) + 0.5 \times 780 \text{ pF} \times 390 \text{ V}^2 \right] = 8.407 \text{ W} \quad (48)$$

Total FET losses

$$P_{\text{COND}} + P_{\text{SW}} = 4.636 \text{ W} + 8.407 \text{ W} = 13.042 \text{ W} \quad (49)$$

The MOSFET requires an appropriately sized heat sink.

### 9.2.2.9 Sense Resistor

To accommodate the gain of the non-linear power limit, the sense resistor,  $R_{\text{SENSE}}$ , is sized such that it triggers the soft over current at 10% higher than the maximum peak inductor current using the minimum soft over current threshold of the ISENSE pin,  $V_{\text{SOC}}$ , of ISENSE equal to 0.265 V.

$$R_{\text{SENSE}} = \frac{V_{\text{SOC}(\text{min})}}{I_{\text{L\_PEAK}(\text{max})} \times 1.1} \quad (50)$$

$$R_{\text{SENSE}} = \frac{0.259 \text{ V}}{7.7 \text{ A} \times 1.1} = 0.032 \Omega \quad (51)$$

The power dissipated across the sense resistor,  $P_{\text{RSENSE}}$ , must be calculated:

$$P_{\text{RSENSE}} = I_{\text{IN\_RMS}(\text{max})}^2 R_{\text{SENSE}} \quad (52)$$

$$P_{\text{RSENSE}} = 4.551 \text{ A}^2 \times 0.032 \Omega = 0.663 \text{ W} \quad (53)$$

The peak current limit, PCL, protection feature is triggered when current through the sense resistor results in the voltage across  $R_{\text{SENSE}}$  to be equal to the  $V_{\text{PCL}}$  threshold. For a worst case analysis, the maximum  $V_{\text{PCL}}$  threshold is used:

$$I_{\text{PCL}} = \frac{V_{\text{PCL}(\text{max})}}{R_{\text{SENSE}}} \quad (54)$$

$$I_{\text{PCL}} = \frac{0.438 \text{ V}}{0.032 \Omega} = 13.688 \text{ A} \quad (55)$$

To protect the device from inrush current, a standard 220- $\Omega$  resistor,  $R_{\text{ISENSE}}$ , is placed in series with the ISENSE pin. A 1000-pF capacitor is placed close to the device to improve noise immunity on the ISENSE pin.

### 9.2.2.10 Output Capacitor

The output capacitor,  $C_{\text{OUT}}$ , is sized to meet holdup requirements of the converter. Assuming the downstream converters require the output of the PFC stage to never fall below 300 V,  $V_{\text{OUT\_HOLDUP}(\text{min})}$ , during one line cycle,  $t_{\text{HOLDUP}} = 1/f_{\text{LINE}(\text{min})}$ , the minimum calculated value for the capacitor is:

$$C_{\text{OUT}(\text{min})} \geq \frac{2P_{\text{OUT}(\text{max})} t_{\text{HOLDUP}}}{V_{\text{OUT}}^2 - V_{\text{OUT\_HOLDUP}(\text{min})}^2} \quad (56)$$

$$C_{\text{OUT}(\text{min})} \geq \frac{2 \times 360 \text{ W} \times 21.28 \text{ ms}}{390 \text{ V}^2 - 300 \text{ V}^2} \geq 247 \mu\text{F} \quad (57)$$

It is advisable to de-rate this capacitor value by 10%; the actual capacitor used is 270  $\mu\text{F}$ .

Verifying that the maximum peak-to-peak output ripple voltage will be less than 5% of the output voltage ensures that the ripple voltage will not trigger the output over-voltage or output under-voltage protection features of the controller. If the output ripple voltage is greater than 5% of the regulated output voltage, a larger output capacitor is required. The maximum peak-to-peak ripple voltage, occurring at twice the line frequency, and the ripple current of the output capacitor is calculated:

$$V_{\text{OUT\_RIPPLE}(\text{pp})} < 0.05 V_{\text{OUT}} \quad (58)$$

$$V_{\text{OUT\_RIPPLE}(\text{pp})} < 0.05 \times 390 \text{ V} = 19.5 \text{ V}_{\text{PP}} \quad (59)$$

$$V_{\text{OUT\_RIPPLE}(\text{pp})} = \frac{I_{\text{OUT}}}{2\pi(2f_{\text{LINE}(\text{min})})C_{\text{OUT}}} \quad (60)$$

$$V_{\text{OUT\_RIPPLE}(\text{pp})} = \frac{0.923 \text{ A}}{2\pi(2 \times 47 \text{ Hz}) \times 270 \mu\text{F}} = 5.789 \text{ V} \quad (61)$$

The required ripple current rating at twice the line frequency is equal to:

$$I_{\text{COUT\_2fline}} = \frac{I_{\text{OUT(max)}}}{\sqrt{2}} \quad (62)$$

$$I_{\text{COUT\_2fline}} = \frac{0.923 \text{ A}}{\sqrt{2}} = 0.653 \text{ A} \quad (63)$$

There is a high frequency ripple current through the output capacitor:

$$I_{\text{COUT\_HF}} = I_{\text{OUT(max)}} \sqrt{\frac{16 V_{\text{OUT}}}{3\pi V_{\text{IN\_RECTIFIED(min)}}} - 1.5} \quad (64)$$

$$I_{\text{COUT\_HF}} = 0.923 \text{ A} \sqrt{\frac{16 \times 390 \text{ V}}{3\pi \times 120 \text{ V}} - 1.5} = 1.848 \text{ A} \quad (65)$$

The total ripple current in the output capacitor is the combination of both and the output capacitor must be selected accordingly:

$$I_{\text{COUT\_RMS(total)}} = \sqrt{I_{\text{COUT\_2fline}}^2 + I_{\text{COUT\_HF}}^2} \quad (66)$$

$$I_{\text{COUT\_RMS(total)}} = \sqrt{0.653 \text{ A}^2 + 1.848 \text{ A}^2} = 1.96 \text{ A} \quad (67)$$

### 9.2.2.11 Output Voltage Set Point

For low power dissipation and minimal contribution to the voltage set point, it is recommended to use 1 M $\Omega$  for the top voltage feedback divider resistor, R<sub>FB1</sub>. Multiple resistors in series are used due to the maximum allowable voltage across each. Using the internal 5-V reference, V<sub>REF</sub>, the bottom divider resistor, R<sub>FB2</sub>, is selected to meet the output voltage design goals.

$$R_{\text{FB2}} = \frac{V_{\text{REF}} R_{\text{FB1}}}{V_{\text{OUT}} - V_{\text{REF}}} \quad (68)$$

$$R_{\text{FB2}} = \frac{5 \text{ V} \times 1 \text{ M}\Omega}{390 \text{ V} - 5 \text{ V}} = 13.04 \text{ k}\Omega \quad (69)$$

A standard value 13-k $\Omega$  resistor for R<sub>FB2</sub> results in a nominal output voltage set point of 391 V.

An output over voltage is detected when the output voltage exceeds its nominal set-point level by 5%, as measured when the voltage at VSENSE is 105% of the reference voltage, V<sub>REF</sub>. At this threshold, the enhanced dynamic response (EDR) is triggered and the non-linear gain to the voltage error amplifier will increase the transconductance to VCOMP and quickly return the output to its normal regulated value. This EDR threshold occurs when the output voltage reaches the V<sub>OUT(ovd)</sub> level:

$$V_{\text{OVD}} = 1.05 V_{\text{REF}} = 1.05 \times 5 \text{ V} = 5.25 \text{ V} \quad (70)$$

$$V_{\text{OUT(ovd)}} = V_{\text{OVD}} \left( \frac{R_{\text{FB1}} + R_{\text{FB2}}}{R_{\text{FB2}}} \right) \quad (71)$$

$$V_{\text{OUT(ovd)}} = 5.25 \text{ V} \times \left( \frac{1 \text{ M}\Omega + 13 \text{ k}\Omega}{13 \text{ k}\Omega} \right) = 410.7 \text{ V} \quad (72)$$

In the event of an extreme output over voltage event, the GATE output will be disabled if the output voltage exceeds its nominal set-point value by 9%. The output voltage, V<sub>OUT(ovp)</sub>, at which this protection feature is triggered is calculated as follows:

$$V_{\text{OUT(ovp)}} = 1.09 \times V_{\text{REF}} \left( \frac{R_{\text{FB1}} + R_{\text{FB2}}}{R_{\text{FB2}}} \right) = 426.4 \text{ V} \quad (73)$$

An output under voltage is detected when the output voltage falls below 5% below its nominal set-point as measured when the voltage at VSENSE is 95% of the reference voltage, V<sub>REF</sub>:

$$V_{\text{UVD}} = 0.95 V_{\text{REF}} = 0.95 \times 5 \text{ V} = 4.75 \text{ V} \quad (74)$$

$$V_{OUT(uvp)} = V_{UVD} \left( \frac{R_{FB1} + R_{FB2}}{R_{FB2}} \right) \quad (75)$$

$$V_{OUT(uvp)} = 4.75 \text{ V} \times \left( \frac{1\text{M}\Omega + 13\text{k}\Omega}{13\text{k}\Omega} \right) = 371.6 \text{ V} \quad (76)$$

A small capacitor on VSENSE must be added to filter out noise. Limit the value of the filter capacitor such that the RC time constant is limited to approximately 10  $\mu\text{s}$  so as not to significantly reduce the control response time to output voltage deviations.

$$C_{VSENSE} = \frac{10\mu\text{s}}{R_{FB2}} = 769\text{pF} \quad (77)$$

The closest standard value of 820 pF was used on VSENSE for a time constant of 10.66  $\mu\text{s}$ .

### 9.2.2.12 Loop Compensation

The current loop is compensated first by determining the product of the internal loop variables,  $M_1M_2$ , using the internal controller constants  $K_1$  and  $K_{FQ}$ . Compensation is optimized maximum load and nominal input voltage, 115  $V_{AC}$  is used for the nominal line voltage for this design:

$$M_1M_2 = \frac{I_{OUT(max)} V_{OUT}^2 2.5R_{SENSE}K_1}{\eta V_{IN\_RMS}^2 K_{FQ}} \quad (78)$$

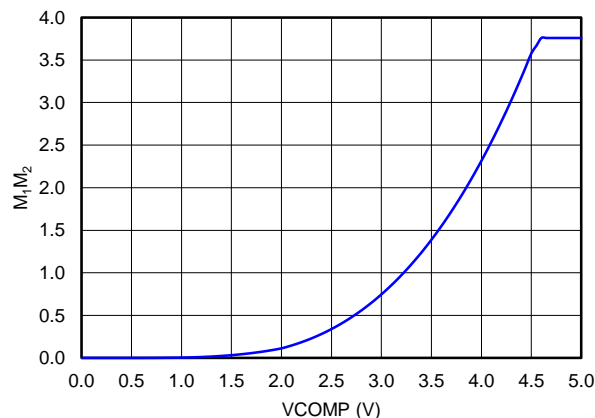
$$K_{FQ} = \frac{1}{f_{SW}}$$

$$K_{FQ} = \frac{1}{118\text{kHz}} = 8.475\mu\text{s}$$

$$K_1 = 7 \quad (79)$$

$$M_1M_2 = \frac{0.923 \text{ A} \times 390 \text{ V}^2 \times 2.5 \times 0.032 \Omega \times 7}{0.92 \times 115 \text{ V}^2 \times 8.475 \mu\text{s}} = 0.751 \frac{\text{V}}{\mu\text{s}} \quad (80)$$

The VCOMP operating point is found on the following chart,  $M_1M_2$  vs. VCOMP. Once the  $M_1M_2$  result is calculated above, find the resultant VCOMP voltage at that operating point to calculate the individual  $M_1$  and  $M_2$  components.



☒ **31.  $M_1M_2$  vs. VCOMP**

For the given  $M_1M_2$  of 0.751  $\text{V}/\mu\text{s}$ , the VCOMP approximately equal to 3 V, as shown in ☒ 31.

The individual loop factors,  $M_1$  which is the current loop gain factor, and  $M_2$  which is the voltage loop PWM ramp slope, are calculated using the following conditions:

The  $M_1$  non-linear current loop gain factor follows the following identities:

$$M_1 = 0.068 \text{ if } V_{\text{COMP}} < 1 \text{ V} \quad (81)$$

$$M_1 = 0.156 \times V_{\text{COMP}} - 0.088 \text{ if } 1 \text{ V} < V_{\text{COMP}} < 2 \text{ V} \quad (82)$$

$$M_1 = 0.313 \times V_{\text{COMP}} - 0.401 \text{ if } 2 \text{ V} < V_{\text{COMP}} < 4.5 \text{ V} \quad (83)$$

$$M_1 = 1.007 \text{ if } 4.5 \text{ V} < V_{\text{COMP}} < 5 \text{ V} \quad (84)$$

In this example, according to the chart in [Figure 31](#), VCOMP is approximately equal to 3 V, so M1 is calculated to be approximately equal to 0.366:

$$M_1 = 0.313 \times 2.45 - 0.401 = 0.366 \quad (85)$$

The M<sub>2</sub> non-linear PWM ramp slope will obey the following relationships:

$$M_2 = 0 \frac{\text{V}}{\mu\text{s}} \text{ if } V_{\text{COMP}} \leq 0.5 \text{ V} \quad (86)$$

$$M_2 = \frac{f_{\text{SW}}}{65\text{kHz}} \times 0.1223 \times (V_{\text{COMP}} - 0.5)^2 \frac{\text{V}}{\mu\text{s}} \text{ if } 0.5 \text{ V} \leq V_{\text{COMP}} \leq 4.6 \text{ V} \quad (87)$$

$$M_2 = \frac{f_{\text{SW}}}{65\text{kHz}} \times 2.056 \frac{\text{V}}{\mu\text{s}} \text{ if } 4.6 \text{ V} \leq V_{\text{COMP}} \leq 5 \text{ V} \quad (88)$$

In this example, with VCOMP approximately equal to 3 V, M<sub>2</sub> equals 1.388 V/μs:

$$M_2 = \frac{118\text{kHz}}{65\text{kHz}} \times 0.1223 \times (3 - 0.5)^2 \frac{\text{V}}{\mu\text{s}} = 1.388 \frac{\text{V}}{\mu\text{s}} \quad (89)$$

Verify that the product of the individual gain factors, M<sub>1</sub> and M<sub>2</sub>, is approximately equal to the M<sub>1</sub>M<sub>2</sub> factor determined above, if not, iterate the VCOMP value and recalculate M<sub>1</sub>M<sub>2</sub>

$$M_1 \times M_2 = 0.538 \times 1.388 \frac{\text{V}}{\mu\text{s}} = 0.747 \frac{\text{V}}{\mu\text{s}} \quad (90)$$

The product of M<sub>1</sub> and M<sub>2</sub> is within 1% of the M<sub>1</sub>M<sub>2</sub> factor previously calculated:

$$M_1 \times M_2 \cong M_1 M_2 \quad (91)$$

$$0.747 \frac{\text{V}}{\mu\text{s}} \cong 0.751 \frac{\text{V}}{\mu\text{s}} \quad (92)$$

If more accuracy was desired, iteration results in a VCOMP value of 3.004 V where M<sub>1</sub>M<sub>2</sub> and M<sub>1</sub> × M<sub>2</sub> are both equal to 0.751 V/μs.

The non-linear gain variable, M<sub>3</sub>, can now be calculated:

$$M_3 = 0 \text{ if } V_{\text{COMP}} < 5 \text{ V} \quad (93)$$

$$M_3 = \frac{f_{\text{SW}}}{65\text{kHz}} \times \frac{\text{V}}{\mu\text{s}} \times (0.0166 \times V_{\text{COMP}} - 0.0083) \text{ if } 0.5 \text{ V} < V_{\text{COMP}} < 1 \text{ V} \quad (94)$$

$$M_3 = \frac{f_{\text{SW}}}{65\text{kHz}} \times \frac{\text{V}}{\mu\text{s}} \times (0.0572 \times V_{\text{COMP}}^2 - 0.0597 \times V_{\text{COMP}} + 0.0155) \text{ if } 1 \text{ V} < V_{\text{COMP}} < 2 \text{ V} \quad (95)$$

$$M_3 = \frac{f_{\text{SW}}}{65\text{kHz}} \times \frac{\text{V}}{\mu\text{s}} \times (0.1148 \times V_{\text{COMP}}^2 - 0.1746 \times V_{\text{COMP}} + 0.0586) \text{ if } 2 \text{ V} < V_{\text{COMP}} < 4.5 \text{ V} \quad (96)$$

$$M_3 = \frac{f_{\text{SW}}}{65\text{kHz}} \times \frac{\text{V}}{\mu\text{s}} \times (0.1148 \times V_{\text{COMP}}^2 - 0.1746 \times V_{\text{COMP}} + 0.0586) \text{ if } 4.5 \text{ V} < V_{\text{COMP}} < 4.6 \text{ V} \quad (97)$$

$$M_3 = 0 \text{ if } 4.6 \text{ V} < V_{\text{COMP}} < 5 \text{ V} \quad (98)$$

In this example, using 3.004 V for VCOMP for a more precise calculation, M<sub>3</sub> calculates to 1.035 V/μs:

$$M_3 = \frac{118\text{kHz}}{65\text{kHz}} \times \frac{\text{V}}{\mu\text{s}} \times (0.1148 \times 3.004^2 - 0.1746 \times 3.004 + 0.0586) = 1.035 \frac{\text{V}}{\mu\text{s}} \quad (99)$$

For designs that allow a high inductor ripple current, the current averaging pole, which functions to flatten out the ripple current on the input of the PWM comparator, should be at least decade before the converter switching frequency. Analysis on the completed converter may be needed to determine the ideal compensation pole for the current averaging circuit as too large of a capacitor on ICOMP will add phase lag and increase  $i_{THD}$  where as too small of an ICOMP capacitor will result in not enough averaging and an unstable current averaging loop. The frequency of the current averaging pole,  $f_{I_{AVG}}$ , is chosen to be at approximately 5 kHz for this design as the current ripple factor,  $\Delta I_{RIPPLE}$ , was chosen at the onset of the design process to be 40%, which is large enough to force DCM operation and result in relatively high inductor ripple current. The required capacitor on ICOMP,  $C_{ICOMP}$ , for this is determined using the transconductance gain,  $g_{mi}$ , of the internal current amplifier:

$$C_{ICOMP} = \frac{g_{mi} \times M_1}{K_1 2\pi f_{I_{AVG}}} \quad (100)$$

$$C_{ICOMP} = \frac{0.95\text{mS} \times 0.538}{7 \times 2 \times \pi \times 5\text{kHz}} = 2330\text{pF} \quad (101)$$

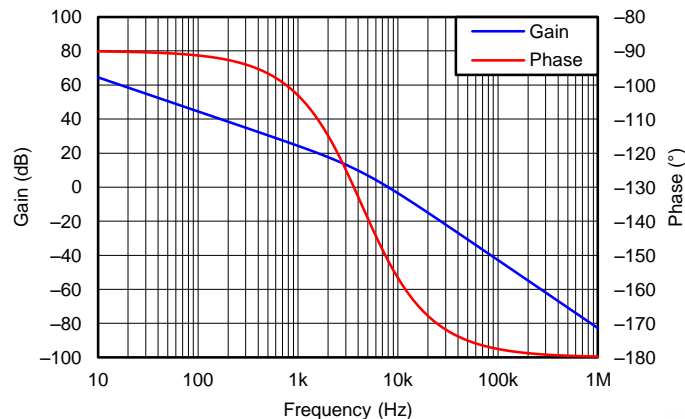
A standard value 2700-pF capacitor for  $C_{ICOMP}$  results in a current averaging pole frequency of 4.314 kHz.

$$f_{I_{AVG}} = \frac{g_{mi} \times M_1}{K_1 \times 2 \times \pi \times 2700\text{pF}} = 4.314\text{kHz} \quad (102)$$

The transfer function of the current loop can be plotted:

$$G_{CL}(f) = \frac{K_1 2.5 R_{SENSE} V_{OUT}}{K_{FQ} M_1 M_2 L_{BST}} \times \frac{1}{s(f) + \frac{s(f)^2 K_1 C_{ICOMP}}{g_{mi} \times M_1}} \quad (103)$$

$$G_{CLdB}(f) = 20 \log(|G_{CL}(f)|) \quad (104)$$



**32. Bode Plot of the Current Averaging Circuit**

The voltage transfer function,  $G_{VL(f)}$  contains the product of the voltage feedback gain,  $G_{FB}$ , and the gain from the pulse width modulator to the power stage,  $G_{PWM\_PS}$ , which includes the pulse width modulator to power stage pole,  $f_{PWM\_PS}$ . The plotted result is shown in [32](#).

$$G_{FB} = \frac{R_{FB2}}{R_{FB1} + R_{FB2}}$$

$$G_{FB} = \frac{13\text{k}\Omega}{1\text{M}\Omega + 13\text{k}\Omega} = 0.013 \quad (105)$$



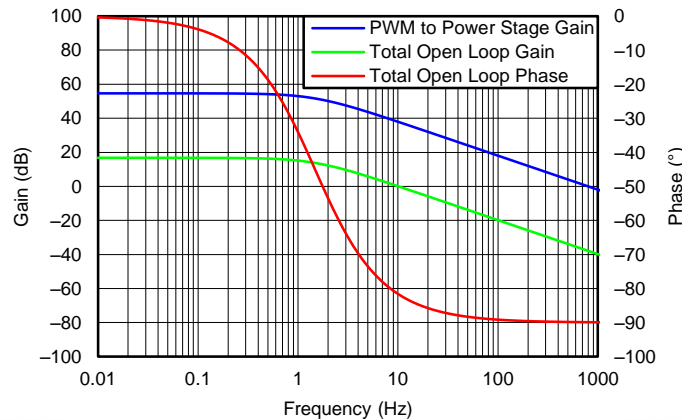
$$f_{\text{PWM\_PS}} = \frac{1}{2\pi \frac{K_1 2.5 R_{\text{SENSE}} V_{\text{OUT}}^3 C_{\text{OUT}}}{K_{\text{FQ}} M_1 M_2 V_{\text{IN(nom)}}^2}}$$

$$f_{\text{PWM\_PS}} = \frac{1}{2\pi \frac{7 \times 2.5 \times 0.032 \Omega \times 390 \text{V}^3 \times 270 \mu\text{F}}{8.475 \mu\text{s} \times 0.539 \times 1.392 \frac{\text{V}}{\mu\text{s}} \times 115 \text{V}^2}} = 1.479 \text{Hz} \quad (106)$$

$$G_{\text{PWM\_PS}}(f) = \frac{\frac{M_3 V_{\text{OUT}}}{M_1 M_2 \times 1 \text{V}}}{1 + \frac{s(f)}{2\pi f_{\text{PWM\_PS}}}} \quad (107)$$

$$G_{\text{VL}}(f) = G_{\text{FB}} G_{\text{PWM\_PS}}(f) \quad (108)$$

$$G_{\text{VLdB}}(f) = 20 \log(|G_{\text{VL}}(f)|)$$



**图 33. Bode Plot of the Open Voltage Loop without Error Amplifier**

The voltage error amplifier is compensated with a zero,  $f_{\text{ZERO}}$ , at the  $f_{\text{PWM\_PS}}$  pole and a pole,  $f_{\text{POLE}}$ , placed at 20 Hz to reject high frequency noise and roll off the gain amplitude. The overall voltage loop crossover,  $f_v$ , is desired to be at 10 Hz. The compensation components of the voltage error amplifier are selected accordingly.

$$f_{\text{ZERO}} = \frac{1}{2\pi R_{\text{VCOMP}} C_{\text{VCOMP}}} \quad (109)$$

$$f_{\text{POLE}} = \frac{1}{2\pi \frac{R_{\text{VCOMP}} C_{\text{VCOMP}} C_{\text{VCOMP\_P}}}{C_{\text{VCOMP}} + C_{\text{VCOMP\_P}}}} \quad (110)$$

$$G_{\text{EA}}(f) = g_{\text{mv}} \left[ \frac{1 + s(f) R_{\text{VCOMP}} C_{\text{VCOMP}}}{(C_{\text{VCOMP}} + C_{\text{VCOMP\_P}}) s(f) \left[ 1 + s(f) \left( \frac{R_{\text{VCOMP}} C_{\text{VCOMP}} C_{\text{VCOMP\_P}}}{C_{\text{VCOMP}} + C_{\text{VCOMP\_P}}} \right) \right]} \right] \quad (111)$$

From **图 33**, the gain of the voltage transfer function at 10 Hz is approximately 0.081 dB. Estimating that the parallel capacitor,  $C_{\text{VCOMP\_P}}$ , is much smaller than the series capacitor,  $C_{\text{VCOMP}}$ , the unity gain will be at  $f_v$ , and the zero will be at  $f_{\text{PWM\_PS}}$ , the series compensation capacitor is determined:

$$f_v = 10 \text{Hz} \quad (112)$$

$$C_{VCOMP} = \frac{g_{mv} \frac{f_V}{f_{PWM\_PS}}}{10^{\frac{0-G_{VLdB}(f)}{20}} \times 2\pi f_V} \tag{113}$$

$$C_{VCOMP} = \frac{56\mu S \times \frac{10\text{Hz}}{1.479\text{Hz}}}{10^{\frac{0-0.081\text{dB}}{20}} \times 2 \times \pi \times 10\text{Hz}} = 6.08\mu F \tag{114}$$

The capacitor for VCOMP must have a voltage rating that is greater than the absolute maximum voltage rating of the VCOMP pin, which is 7 V. The readily available standard value capacitor that is rated for at least 10 V in the package size that would fit the application was 4.7 μF and this is the value used for C<sub>VCOMP</sub> in this design example.

R<sub>VCOMP</sub> is calculated using the actual C<sub>VCOMP</sub> capacitor value.

$$C_{VCOMP} = 4.7\mu F \tag{115}$$

$$R_{VCOMP} = \frac{1}{2\pi f_{ZERO} C_{VCOMP}} \tag{116}$$

$$R_{VCOMP} = \frac{1}{2 \times \pi \times 1.479\text{Hz} \times 4.7\mu F} = 22.89\text{k}\Omega \tag{117}$$

A 22.6-kΩ resistor is used for R<sub>VCOMP</sub>.

$$C_{VCOMP\_P} = \frac{C_{VCOMP}}{2\pi f_{POLE} R_{VCOMP} C_{VCOMP} - 1} \tag{118}$$

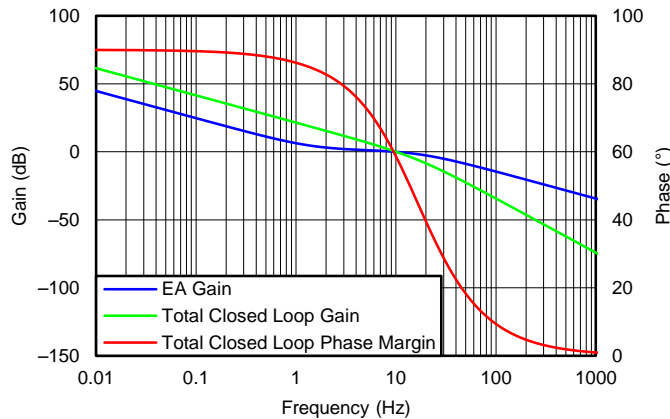
$$C_{VCOMP\_P} = \frac{4.7\mu F}{2 \times \pi \times 20\text{Hz} \times 22.6\text{k}\Omega \times 4.7\mu F - 1} = 0.381\mu F \tag{119}$$

A 0.47-μF capacitor is used for C<sub>VCOMP\_P</sub>.

The total closed loop transfer function, G<sub>VL\_total</sub>, contains the combined stages and is plotted in [Figure 34](#).

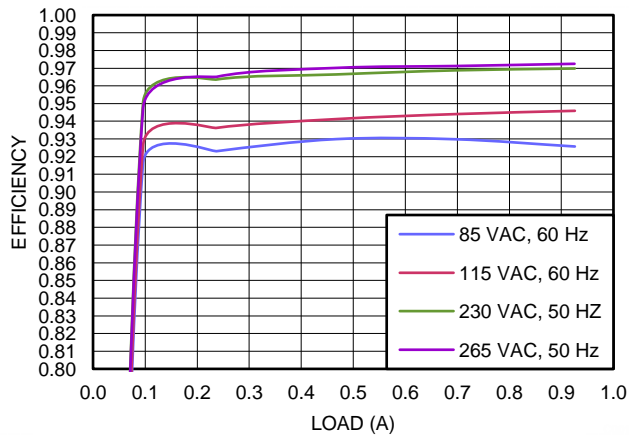
$$G_{VL\_total}(f) = G_{FB}(f)G_{PWM\_PS}(f)G_{EA}(f) \tag{120}$$

$$G_{VL\_totaldB}(f) = 20\log(G_{VL\_total}(f)) \tag{121}$$

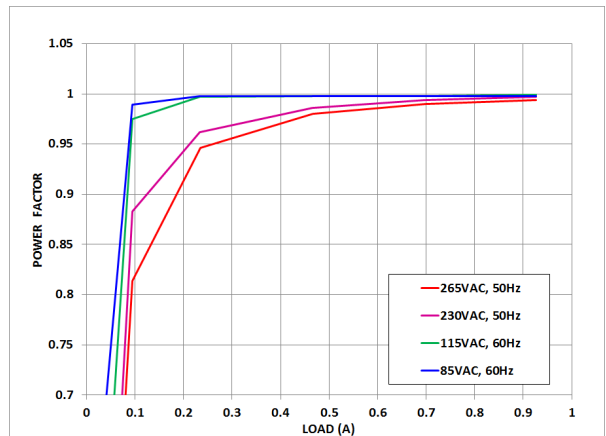


**Figure 34. Closed Loop Voltage Bode Plot**

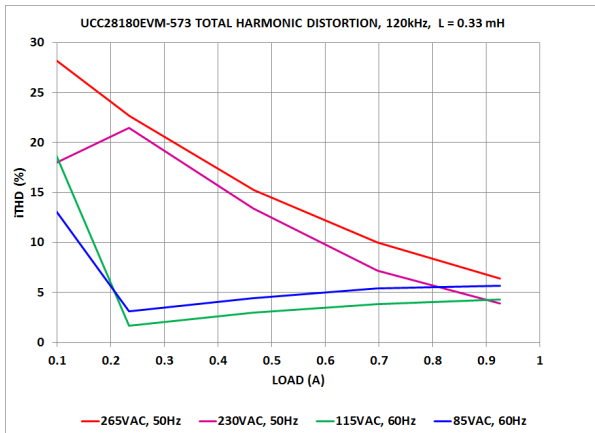
9.2.3 Application Curve



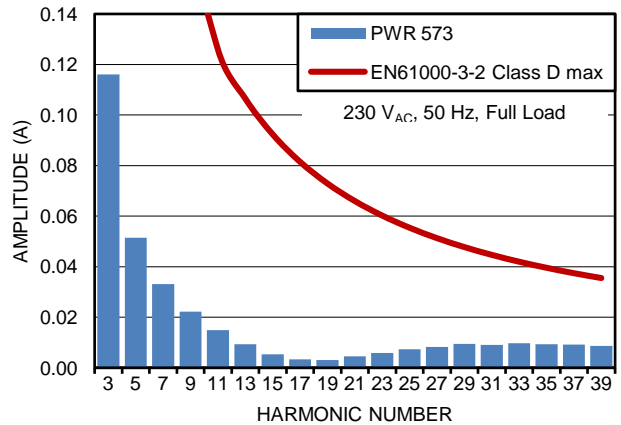
35. UCC28180EVM-573 Efficiency (As a Function of Line Voltage and Load Current)



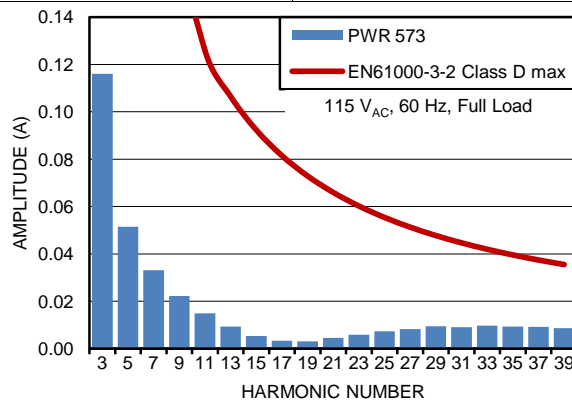
36. UCC28180EVM-573 Power Factor (As a Function of Line Voltage and Load Current)



37. UCC28180EVM-573 Total Harmonic Distortion (As a Function of Line Voltage and Load Current)



38. UCC28180EVM-573 Current Harmonics, (230-V<sub>AC</sub>, 50-Hz Input, Full Load, Without the Fundamental)



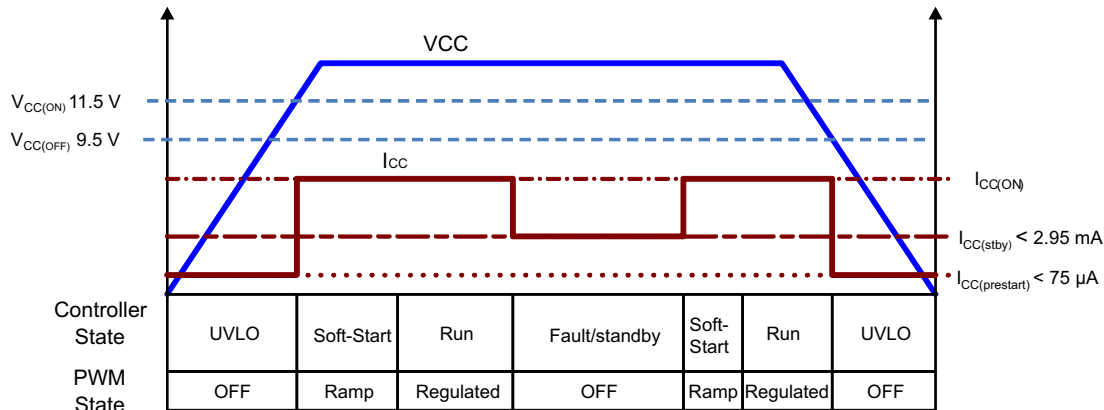
39. UCC28180EVM-573 Current Harmonics, (115-V<sub>AC</sub>, 60-Hz Input, Full Load, Without the Fundamental)

## 10 Power Supply Recommendations

### 10.1 Bias Supply

The UCC28180 operates from an external bias supply. It is recommended that the device be powered from a regulated auxiliary supply. (This device is not intended to be used from a *bootstrap* bias supply. A *bootstrap* bias supply is fed from the input high voltage through a resistor with sufficient capacitance on VCC to hold up the voltage on VCC until current can be supplied from a bias winding on the boost inductor. For that reason, the minimal hysteresis on VCC would require an unreasonable value of hold-up capacitance.)

During normal operation, when the output is regulated, current drawn by the device includes the nominal run current plus the current supplied to the gate of the external boost switch. Decoupling of the bias supply must take switching current into account in order to keep ripple voltage on VCC to a minimum. A ceramic capacitor of 0.1- $\mu$ F minimum value from VCC to GND with short, wide traces is recommended.



⊠ 40. Device Supply States

The device's bias operates in several states. During startup, VCC Under-Voltage LockOut (UVLO) sets the minimum operational DC input voltage of the controller. There are two UVLO thresholds. When the UVLO turn-on threshold is exceeded, the PFC controller turns ON. If the VCC voltage falls below the UVLO turn-off threshold, the PFC controller turns off. During UVLO, current drawn by the device is minimal. After the device turns on, Soft Start (SS) is initiated and the boost inductor current is ramped up in a controlled manner to reduce the stress on the external components and avoids output voltage overshoot. During soft start and after the output is in regulation, the device draws its normal run current. If any of several fault conditions are encountered or if the device is put in standby with an external signal, the device draws a reduced standby current.

## 11 Layout

### 11.1 Layout Guidelines

As with all PWM controllers, the effectiveness of the filter capacitors on the signal pins depends upon the integrity of the ground return. Separating the high di/dt induced noise on the power ground from the low current quiet signal ground is required for adequate noise immunity. Even with a signal layer PCB design, the pin out of the UCC28180 is ideally suited to minimize noise on the small signal traces. As shown in ⊠ 41, the capacitors on VSENSE, VCOMP, ISENSE, ICOMP, and FREQ (if used) must all be returned directly to the portion of the ground plane that is the quiet signal GND and not in high-current return path of the converter, shown as power GND. The trace from the FREQ pin to the frequency programming resistor should be as short as possible. It is recommended that the compensation components on ICOMP and VCOMP are located as close as possible to the UCC28180. Placement of these components should take precedence, paying close attention to keeping their traces away from high noise areas. The bypass capacitors on VCC must be located physically close the VCC and GND pins of the UCC28180 but should not be in the immediate path of the signal return.

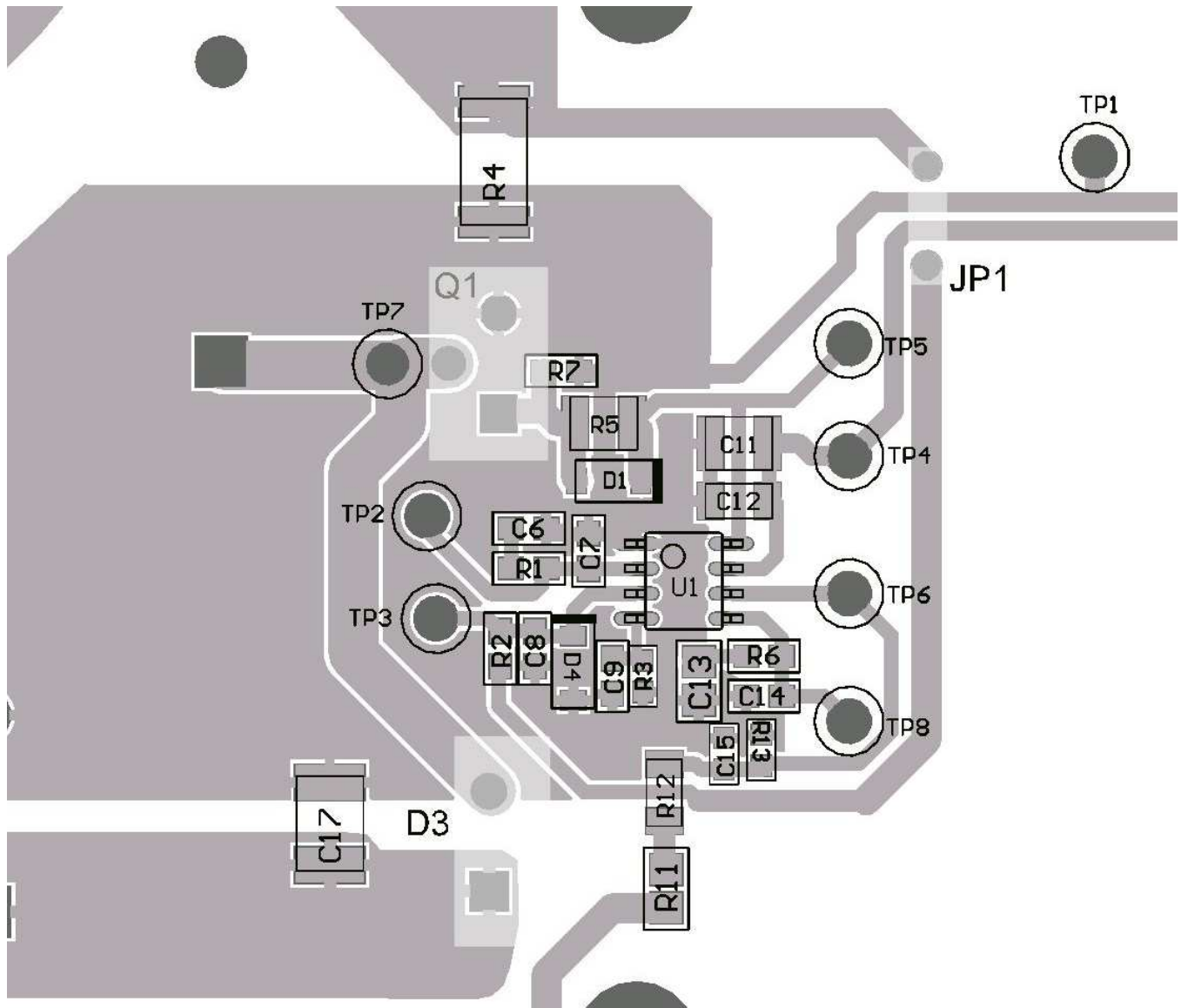
## Layout Guidelines (continued)

Other layout considerations should include keeping the switch node as short as possible, with a wide trace to reduce induced ringing caused by parasitic inductance. Every effort should be made to avoid noise from the switch node from corrupting the small signal traces with adequate clearance and ground shielding. As some compromises must be made due to limitation of PCB layers or space constraints, traces that must be made long, such as the signal from the current sense resistor shown in [Figure 41](#), should be as wide as possible, avoid long narrow traces.

**表 2. Layout Component Description for [Figure 41](#)**

LAYOUT COMPONENTS	
REFERENCE DESIGNATOR	FUNCTION
U1	Controller, UCC28180
Q1	Main switch
D2	Boost diode
R5	RGATE
R7	Pull-down resistor on GATE
D1	Turn-off diode on GATE
D4	ISENSE pin diode
C11, C12	VCC bypass capacitors
C7	ICOMP compensation, $C_{ICOMP}$
R1, C6	Placeholders for additional ICOMP compensation, if needed
C8	ISENSE filter, $C_{ISENSE}$
R2	ISENSE inrush current limiting resistor, $R_{ISENSE}$
R3	Frequency programming resistor, $R_{FREQ}$
C9	Placeholder for FREQ filter, if needed
R6, C13, C14	VCOMP compensation components, $R_{VCOMP}$ , $C_{VCOMP\_P}$ , $C_{VCOMP}$
C15	VSENSE filter, $C_{VSENSE}$
R11, R12	$R_{FB1}$ on VSENSE
R13	$R_{FB2}$ on VSENSE

**11.2 Layout Example**



☒ 41. Recommended Layout for UCC28180

## 12 デバイスおよびドキュメントのサポート

### 12.1 ドキュメントのサポート

#### 12.1.1 関連資料

以下の参考文献、追加設計ツール、および設計ソフトウェアやモデルを含む他の参考資料へのリンクを、<http://www.power.ti.com>の「技術資料」で参照できます。

- ユーザ・ガイド、『*UCC28180EVM-573の使用、360W力率補正*』、[SLUUAT3](#)
- 設計用スプレッド・シート、『*UCC28180設計用カリキュレータ*』、[SLUC506](#)

### 12.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、[ti.com](http://ti.com)のデバイス製品フォルダを開いてください。右上の隅にある「通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

### 12.3 コミュニティ・リソース

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### 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。これらの情報は、指定のデバイスに対して提供されている最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">UCC28180D</a>	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180D.A	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180D.B	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
<a href="#">UCC28180DR</a>	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180DR.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180DR.B	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180DRG4	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180DRG4.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180
UCC28180DRG4.B	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	U28180

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
UCC28180DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
UCC28180DRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
UCC28180DR	SOIC	D	8	2500	353.0	353.0	32.0
UCC28180DRG4	SOIC	D	8	2500	353.0	353.0	32.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
UCC28180D	D	SOIC	8	75	507	8	3940	4.32
UCC28180D.A	D	SOIC	8	75	507	8	3940	4.32
UCC28180D.B	D	SOIC	8	75	507	8	3940	4.32



D0008A

# PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

## NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed  $.006$  [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

# EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
 EXPOSED METAL SHOWN  
 SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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